

# **IRST SiPM characterizations and Application Studies**

G. Pauletta  
for the  
**FACTOR**  
collaboration

## **Outline**

1. Introduction (who and where)
2. Objectives and program (what and how)
3. characterizations
4. Applications

# FACTOR

3-year project (2007 – 2009) funded by INFN

*Participants:*

INFN laboratories and/or universities at: Trieste, Udine, Messina  
*collaborating with*  
ITC (now Bruno Kessler Foundation) -IRST  
Trento, Italy

## Background:

2005: INFN funds project (DASiPM) for the development of SiPM devices, mainly for PET application

2007: INFN funds continuation of DASiPM and expands development to other applications (FACTOR)

INFN-Trieste has a long – standing collaboration with IRST in the development of Silicon-based detectors for application in accelerator, underground and space – based experimental particle physics.

# Motivations

The FACTOR collaboration interested in the development of the device and in its optimization for application to:

## Present application interests:

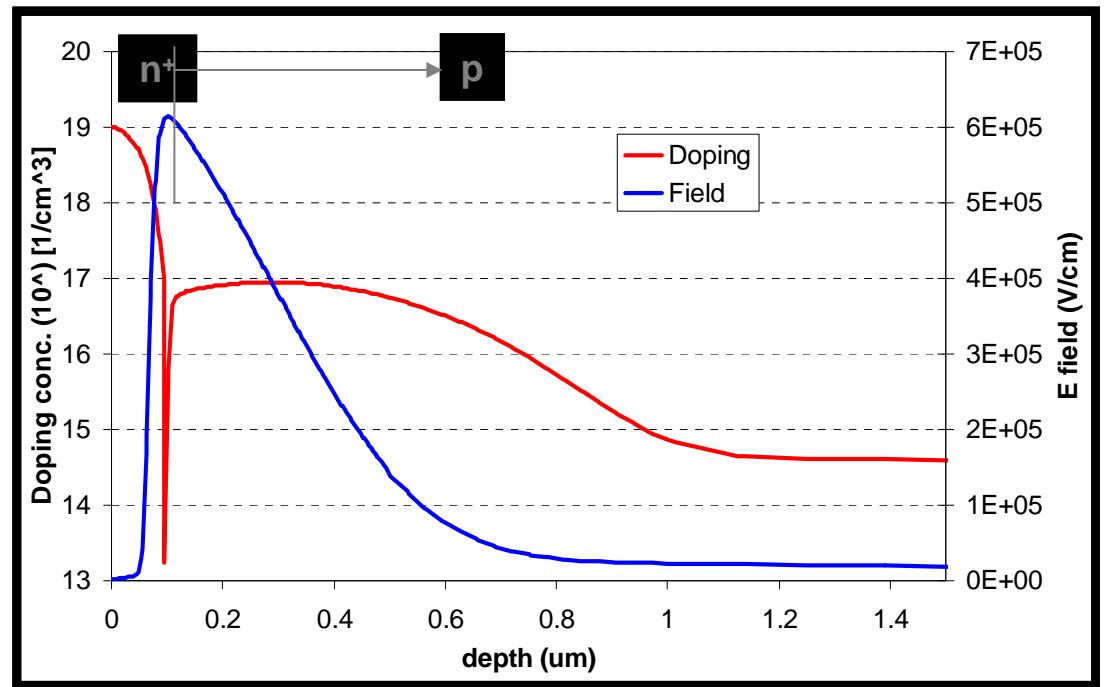
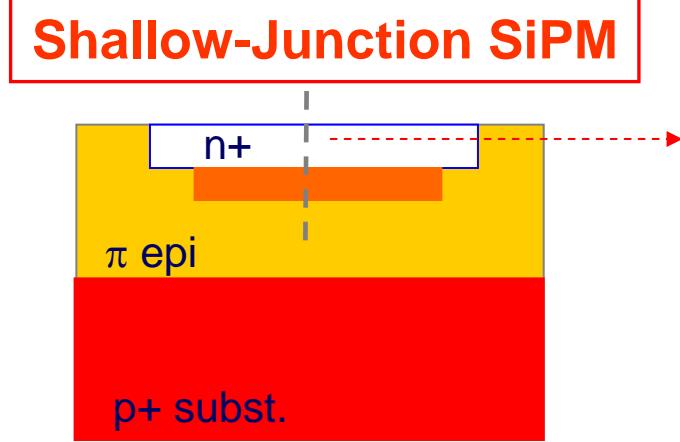
- Calorimetry with fiber-based optical readout
- Large – area scintillator – based muon counters
- Scintillating fiber – based tracking
- future space experiments for detection of UHECR
- FEL studies and instrumentation
- future large – area, ground – based x-ray telescopes

## Action Plan:

- comparative studies for detailed understanding of device characteristics
- Application tests
- Optimization of properties as a function of application

# Present IRST technology\*

\*C. Piemonte “A new Silicon Photomultiplier structure for blue light detection” NIMA 568 (2006)



Distinguishing characteristics:

- 1) Very shallow junction
- 2) ARC optimized for short wavelengths (~400nm)
- 3) polysilicon quenching resistors

# Development History

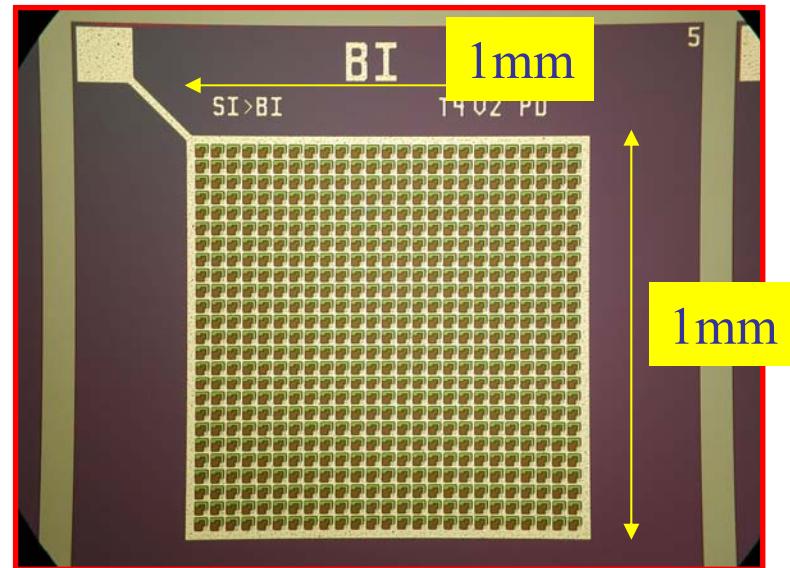
Development started at the beginning of 2005

## Baseline geometry

SiPM structure:

- 25x25 cells
- microcell size: 40x40mm<sup>2</sup>

Development has continued over last two years: several succeeding production runs to develop geometries for different applications and to optimize operational characteristics



Geometry of baseline model  
NOT optimized for maximum PDE  
( fill factor ~20% ).

# Principal characteristics of interest

- Gain
- Noise
  - dark count
  - afterpulsing
  - optical cross-talk
- PhotoDetection Efficiency (PDE)
- Dynamic Range
- Time characteristics
  - rise - time, resolution, recovery time
- Radiation hardness
- Sensitivity to magnetic fields

## Other considerations

- Packaging
- Readout electronics

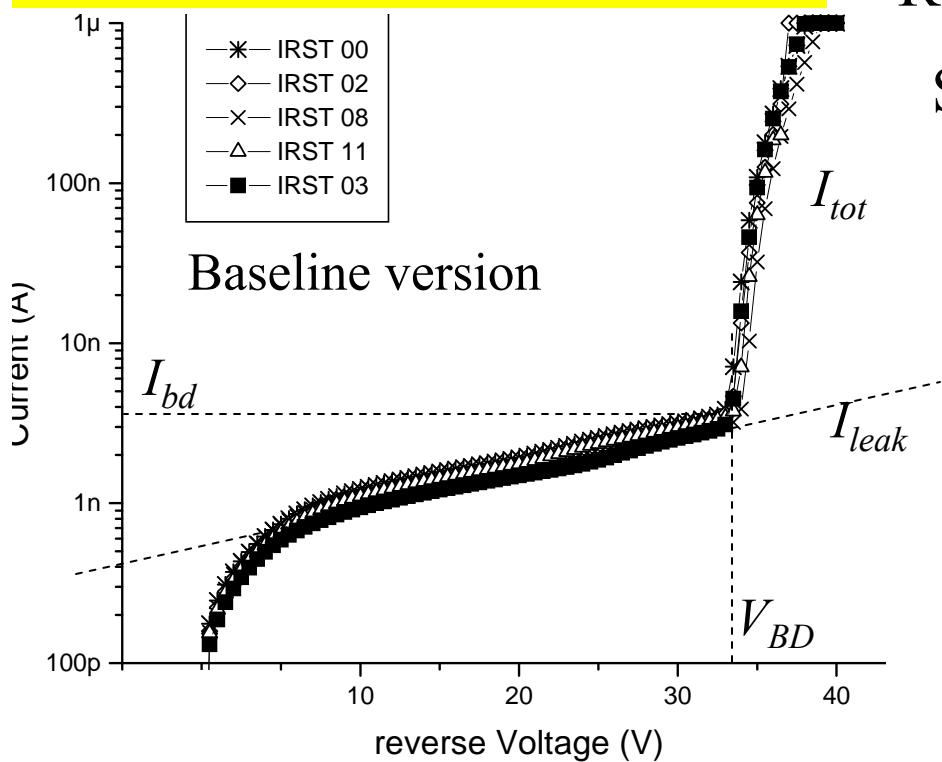
# Device characterization<sup>1,2</sup>

- Static measurements: IV measurements for rapid test of device properties, uniformity and stability
- Dynamic tests: Output signal characterization and stability using noise signals in the dark
  - Signal rise time and fall time
  - Gain
  - Dark count
  - Optical cross - talk
  - Afterpulsing
- PhotoDetection Efficiency

1)All characterizations reported here are for 1mm<sup>2</sup> devices

2) for a thorough characterization of the first SiPM prototypes fabricated at ITC-irst see C. Piemonte, IEEE TNS, February 2007

# Static measurements-1



SiPM	V <sub>bd</sub> (V)	I <sub>bd</sub> (nA)
IRST-00	32,5	3,6
IRST-02	33,0	3,6
IRST-03	33,0	3,1
IRST-08	33,5	3,2
IRST-11	33,5	3,8

Rapid check functionality & uniformity

Sensitive to principal characteristics

$$\text{dark current } I_{dc} = I_{tot} - I_{leak}$$

is prop. to gain  $G$  and dark count ( $DC$ )

$$I_{dc} \propto G.(DC)$$

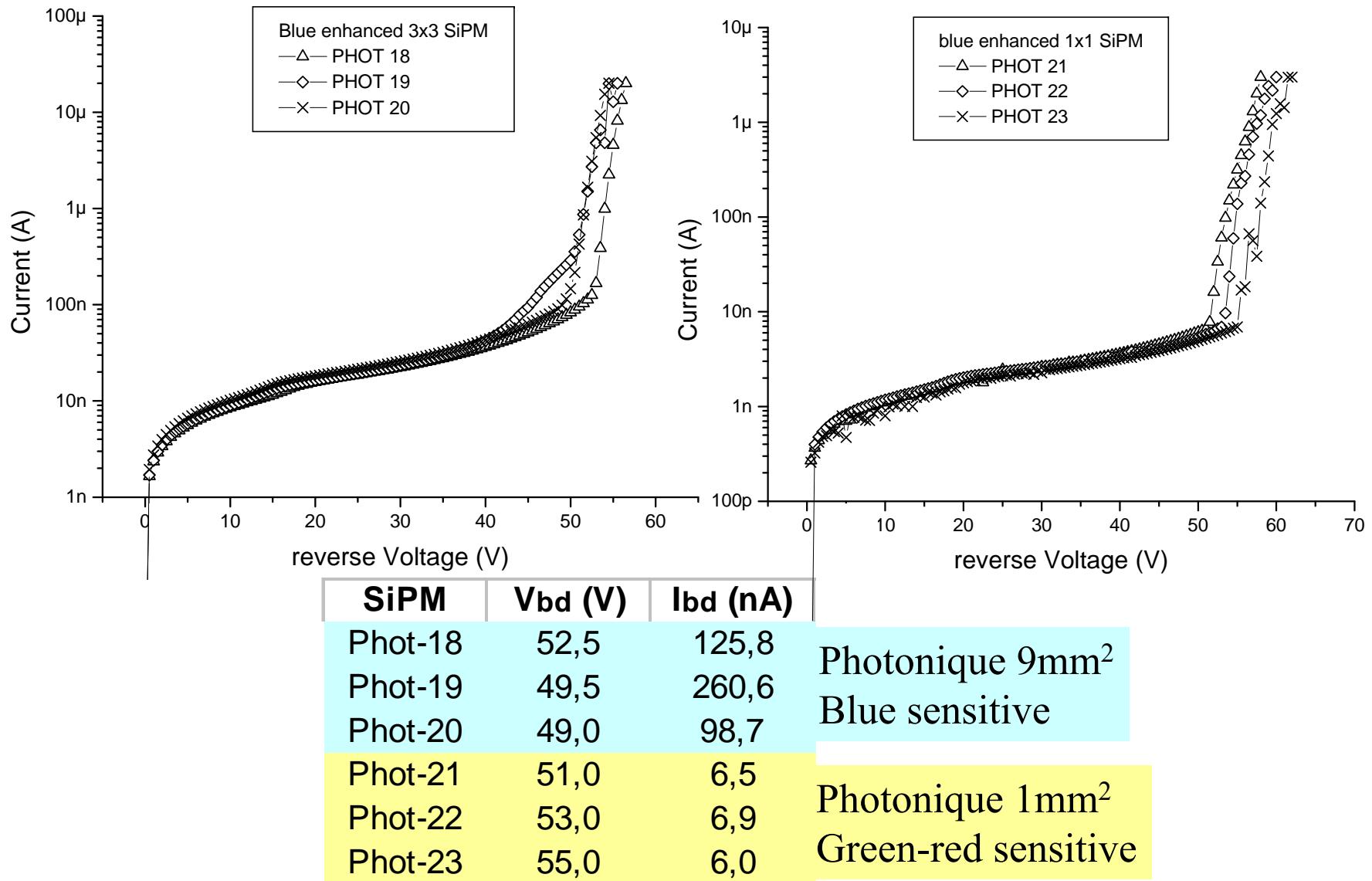
and since  $G \propto V$ ,  $DC \propto V$

$$I_{dc} \propto V^2$$

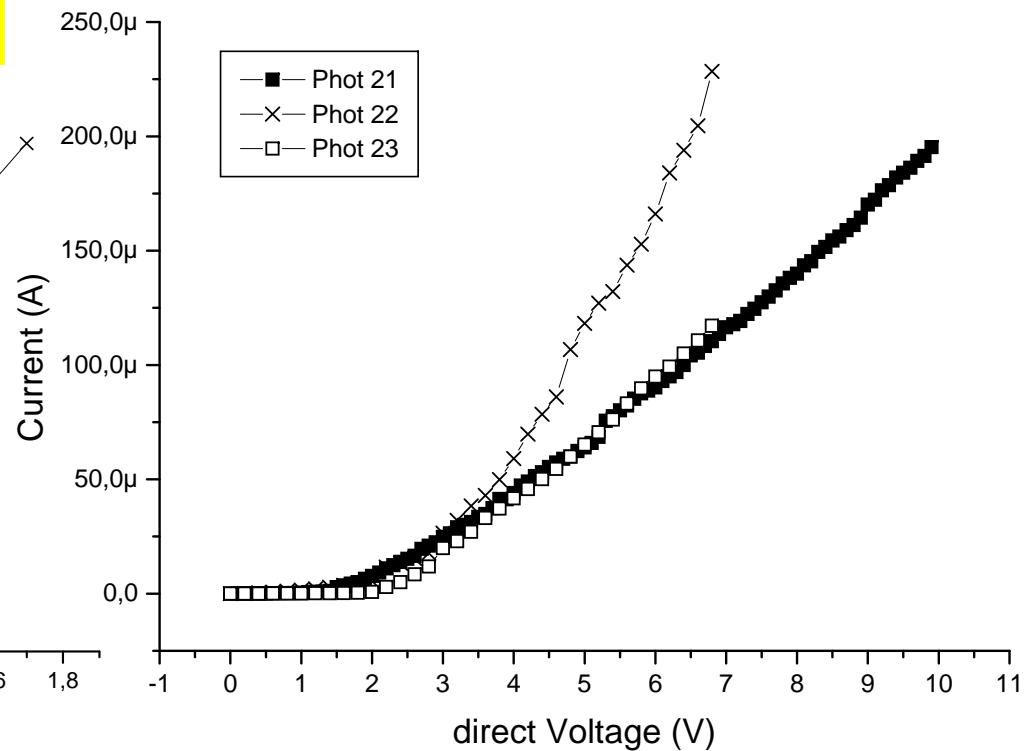
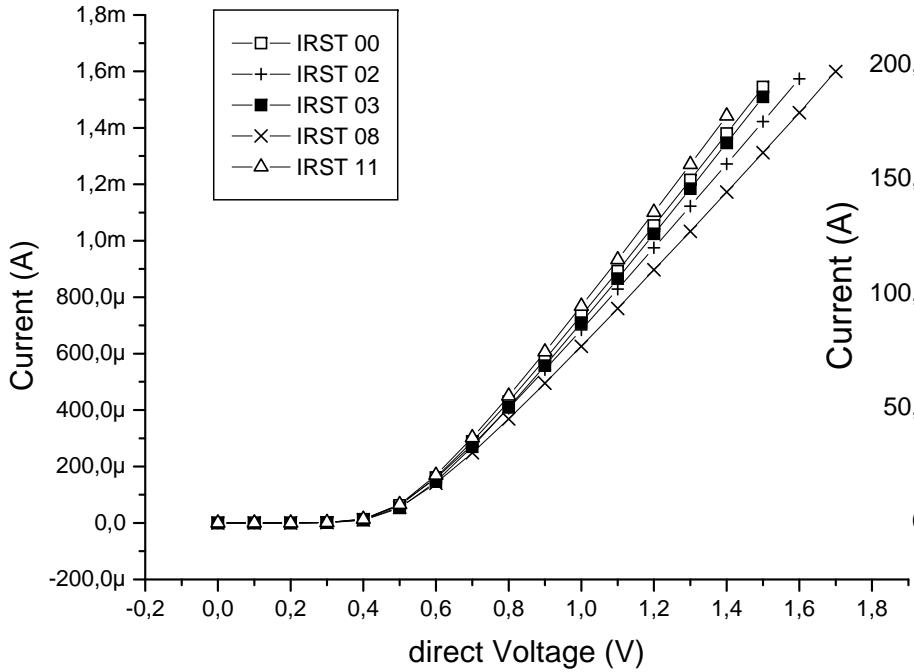
IRST 1mm<sup>2</sup>  
second batch

IRST devices generally very uniform

## Static measurements-2



# Static measurements-3



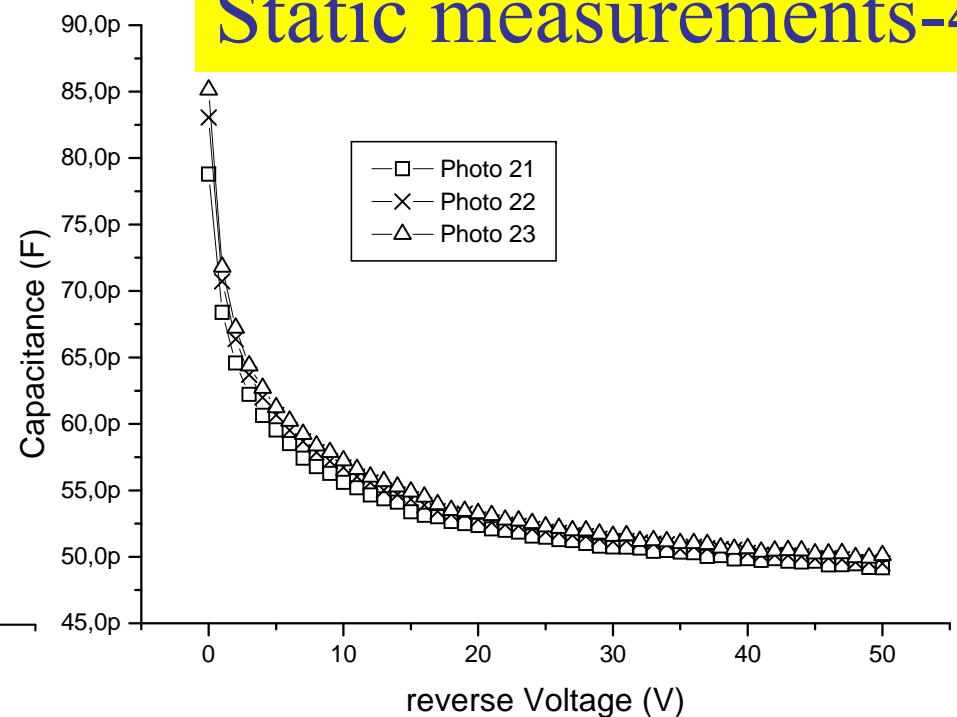
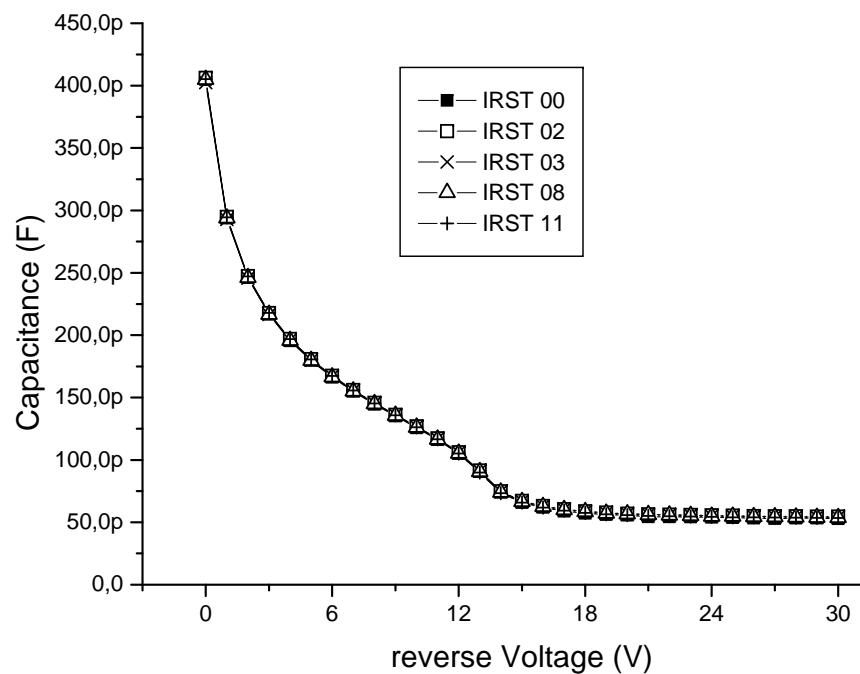
<b>SiPM</b>	<b>Rq (Ohm)</b>
IRST-00	669
IRST-02	612
IRST-03	619
IRST-08	697
IRST-11	590

IRST 1mm<sup>2</sup>  
second batch

$$\times 625 \approx 390k\Omega$$

<b>SiPM</b>	<b>Rq (kOhm)</b>	
Phot-18	2,29	Photonique 9mm <sup>2</sup>
Phot-19	1,52	Blue sensitive
Phot-20	1,24	
Phot-21	39,8	Photonique 1mm <sup>2</sup>
Phot-22	17,4	Green-red sensitive
Phot-23	37,8	

## Static measurements-4



SiPM	V <sub>dep</sub> (V)	C <sub>dep</sub> (pF)
IRST-00	21	54
IRST-02	21	55
IRST-03	21	55
IRST-08	21	55
IRST-11	21	54

$$\div 625 \approx 90 \text{ fF}$$

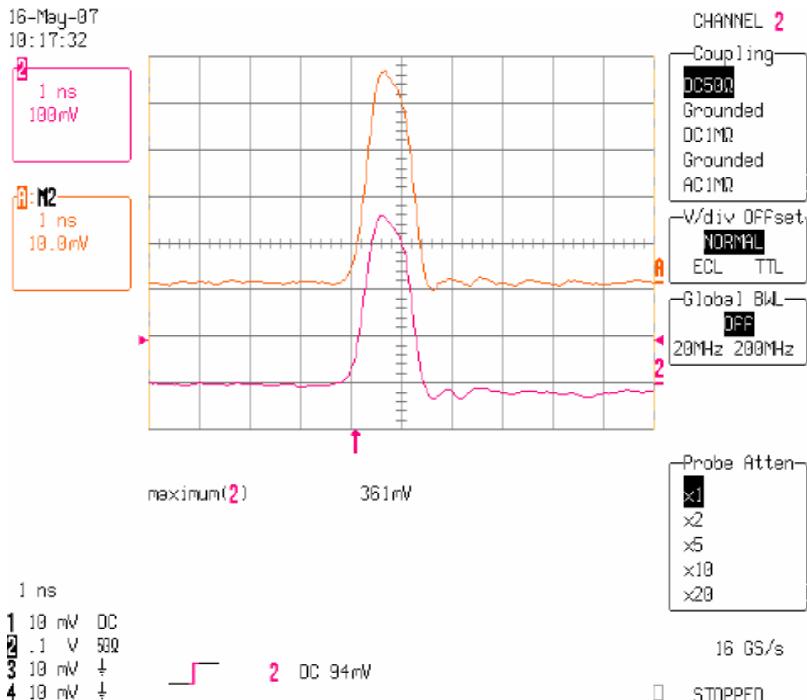
# dynamic measurements-1

Amplifier used for fast characterization of SiPMs:

Agilent ABA-52563 3.5 GHz RFIC Amplifier

(economic, compact, internally  $50\text{-}\Omega$  matched, gain  $\sim 20$  dB)

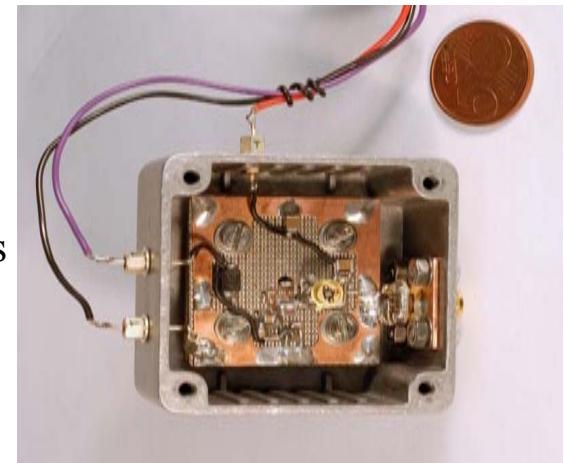
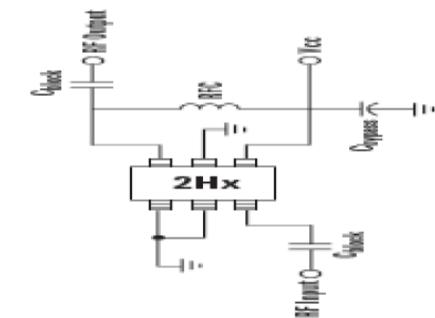
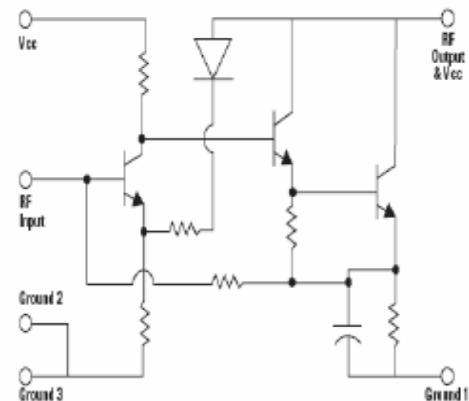
Dimensions  $1.8 \times 1.8 \text{ mm}^2$



Orange trace: input from pulse generator, FWHM = 0.9 ns, tr = tf = 300 ps  
 Red trace: amplifier's output

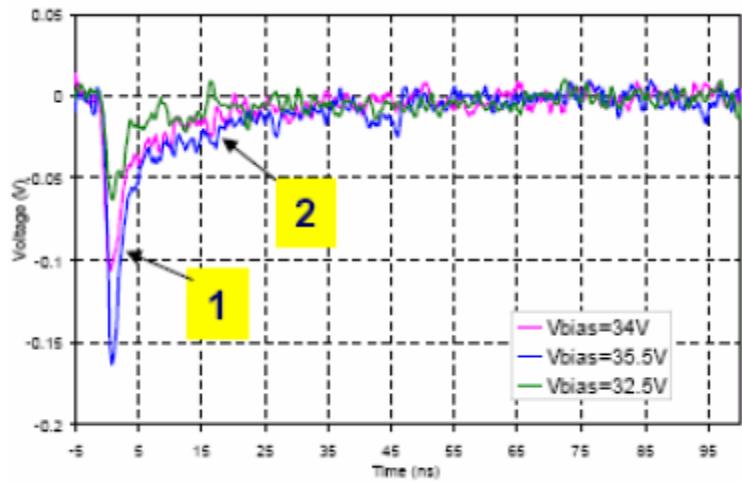


Simplified Schematic



# dynamic measurements-2

*IRST :recovery time  $\sim 70$  ns*

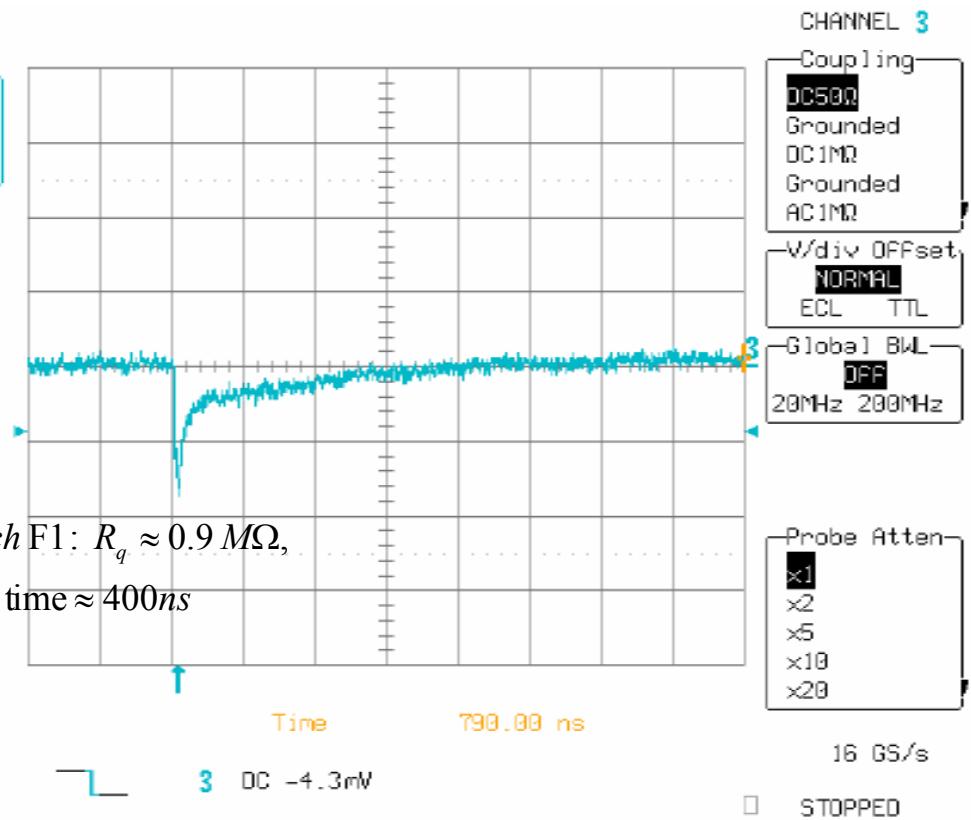


4-Jun-07  
14:50:24

3  
.1  $\mu$ s  
5.0mV  
0.62mV

*Formitech F1:  $R_q \approx 0.9 M\Omega$ ,  
recovery time  $\approx 400$  ns*

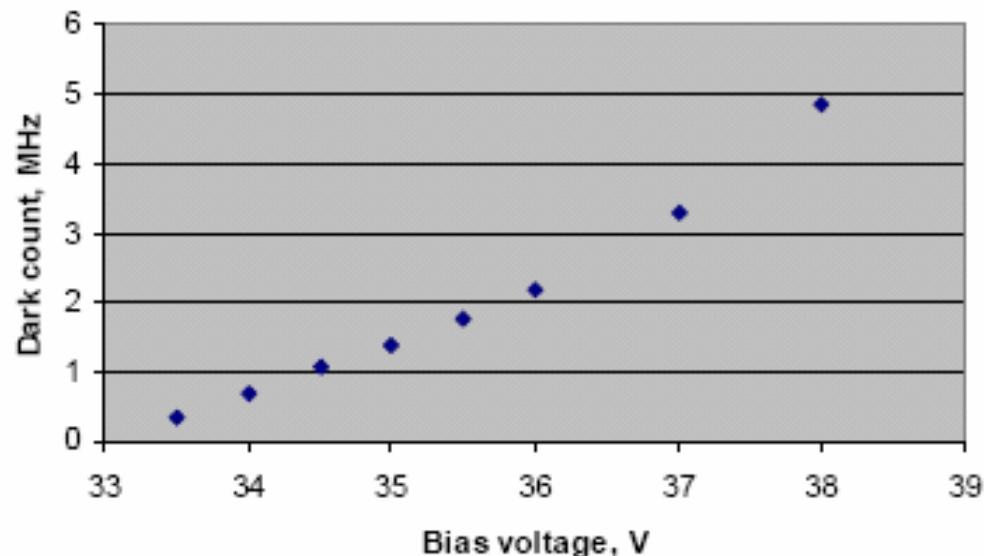
.1  $\mu$ s  
1 5 mV 500  
2 10 mV 500  
3 5 mV 500  
4 10 mV ↓



MRS SiPMs have 2.5 to 50 times larger  $R_q$  values than IRST (polysilicon) devices  
→ longer recovery times

# dynamic measurements-4

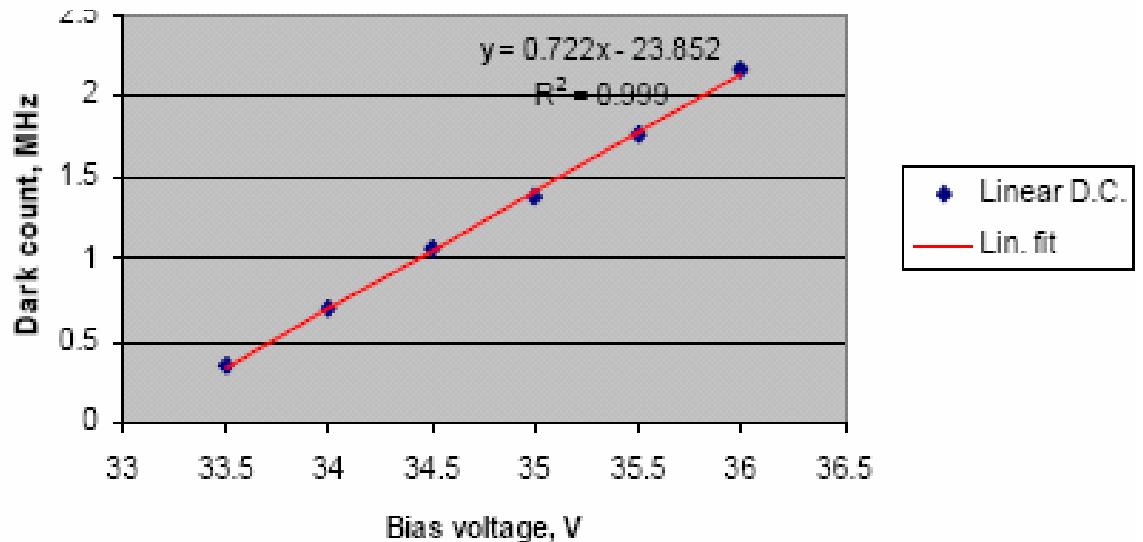
Dark count IRST\_A1



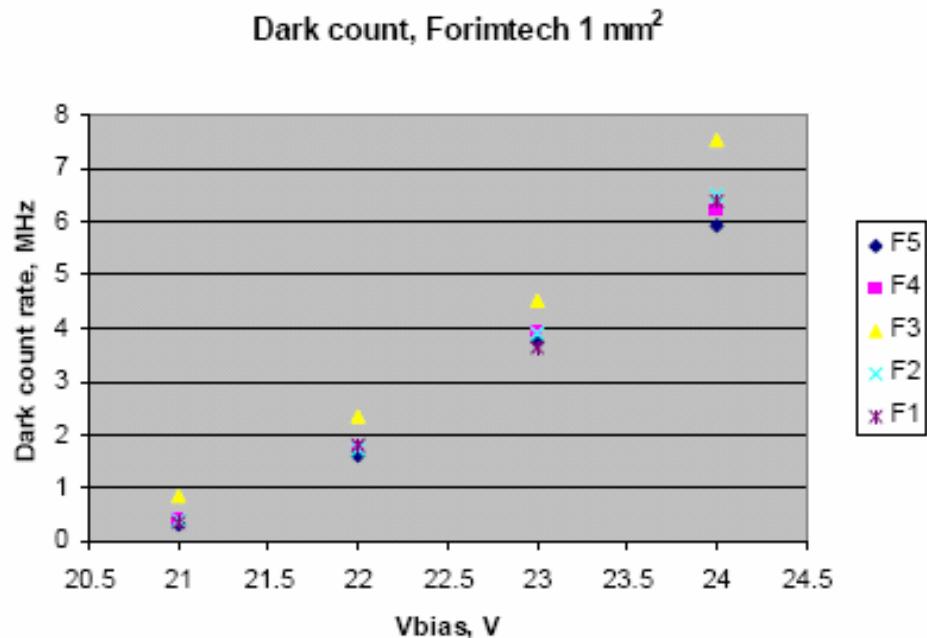
1 mm<sup>2</sup> type A  
VBD ≈ 33 V  
D.C.(ΔV=2V) ≈ 1.5 MHz

Dark count IRST\_A1

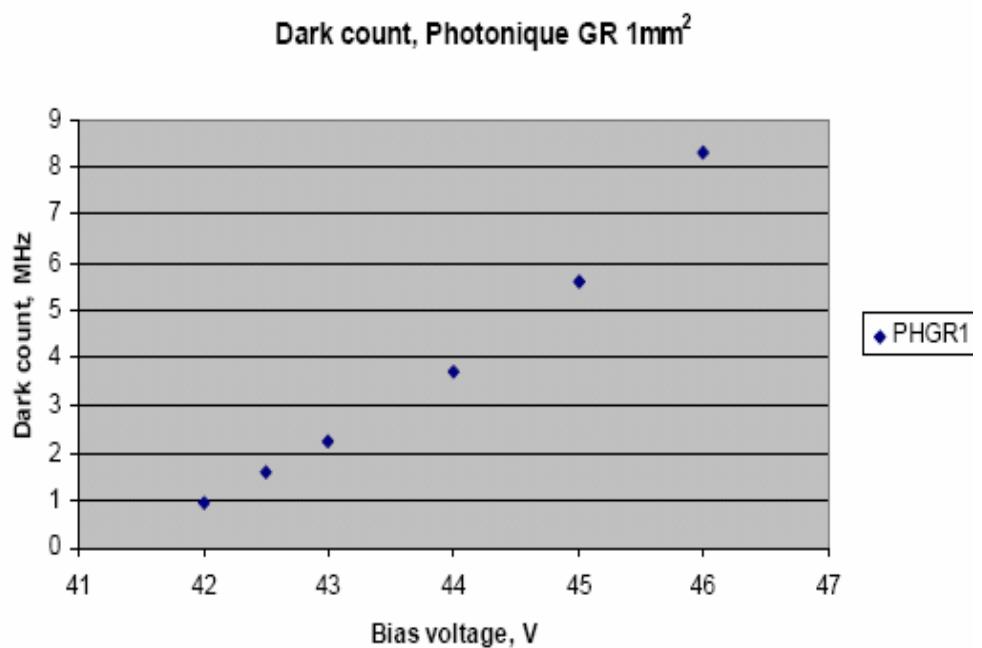
Linear fit intercept with V-axis  
gives VBD = 33.04 V



# dynamic measurements-4

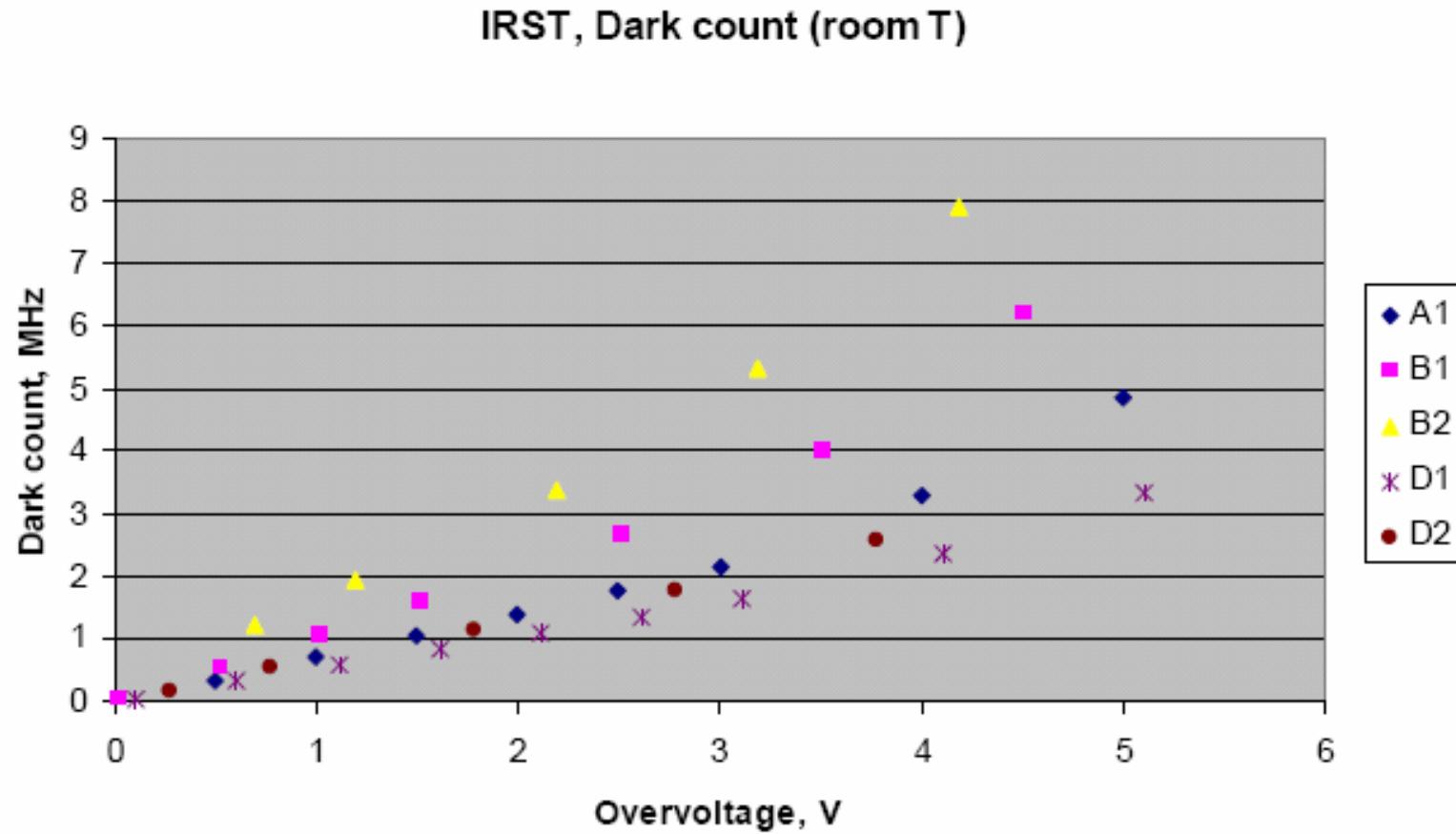


1 mm<sup>2</sup> MRS devices  
VBD  $\approx$  20 V  
D.C.( $\Delta V=2V$ )  $\approx$  2 MHz



1 mm<sup>2</sup> MRS device  
VBD  $\approx$  41 V  
D.C.( $\Delta V=2V$ )  $\approx$  2.2 MHz

# dynamic measurements-5



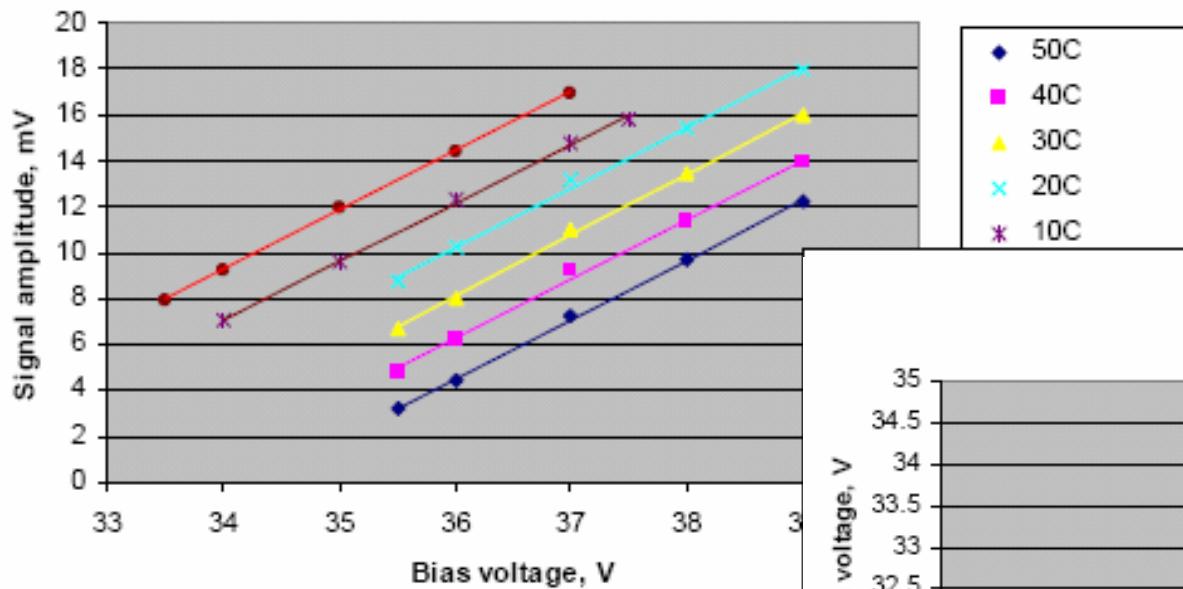
type “A”, D.C.( $\Delta V=2V$ )  $\approx 1.5$  MHz

type “B”, D.C.( $\Delta V=2V$ )  $\approx 2-3$  MHz

type “D”, D.C.( $\Delta V=2V$ )  $\approx 1$  MHz

# dynamic measurements-6

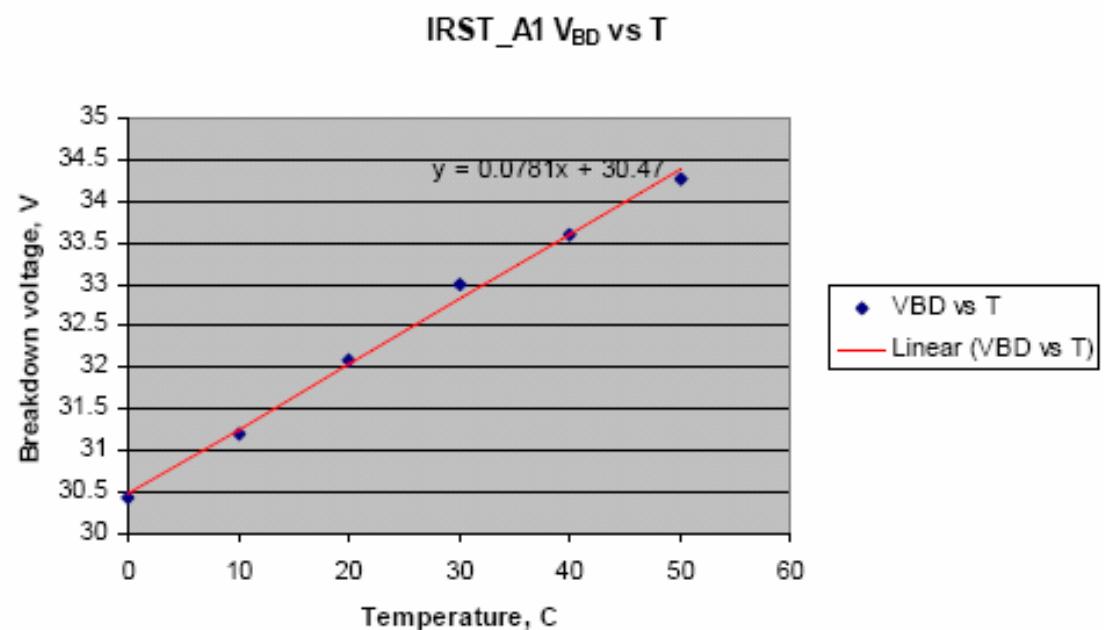
IRST\_A1



Measurements performed in a climatic chamber (with humidity control)

The amplifier was located outside the chamber, connection via a special 18 GHz ft 50 Ω cable

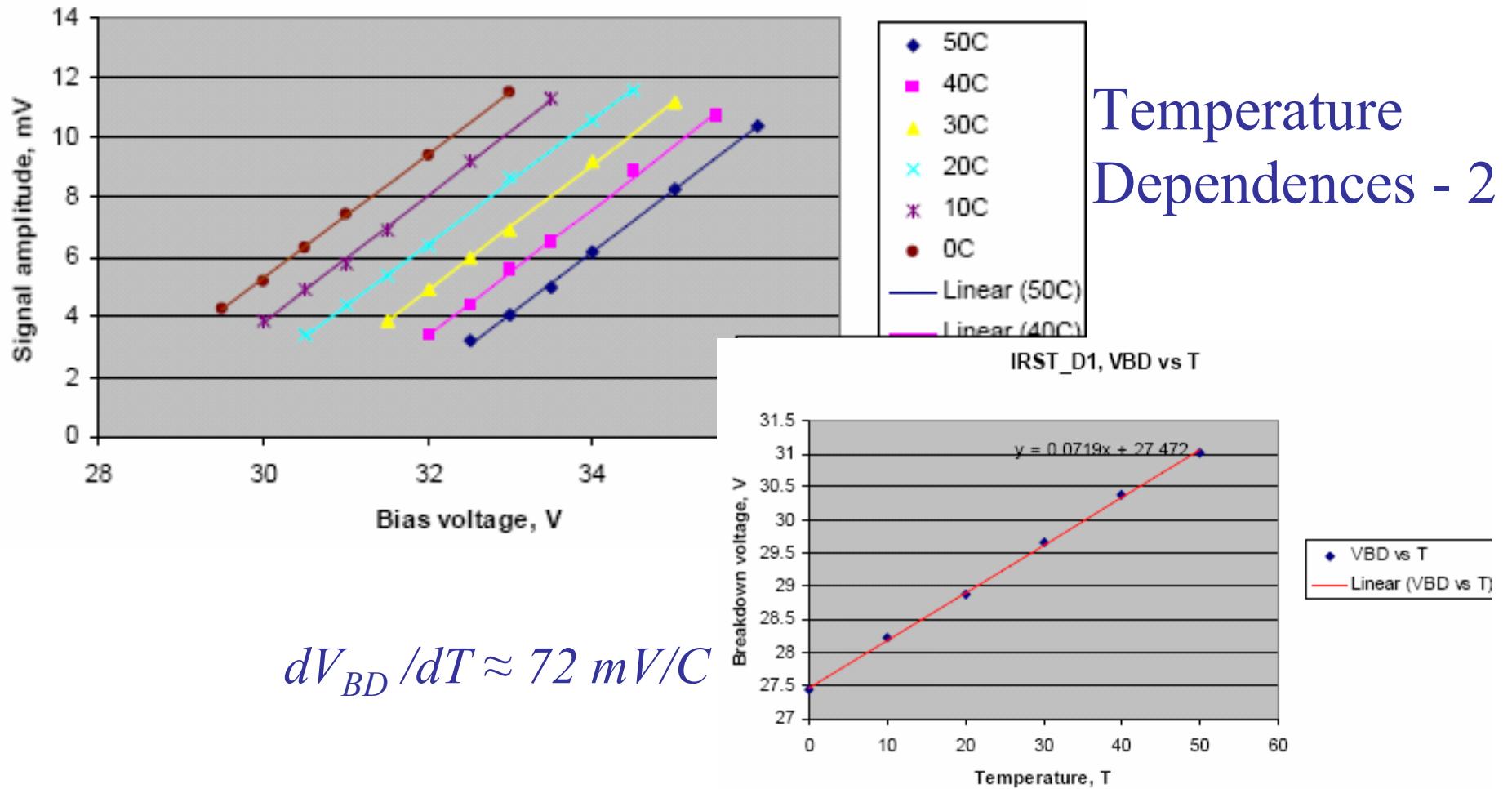
## Temperature Dependences - 1



$$dV_{BD}/dT \approx 78 \text{ mV/C}$$

# dynamic measurements-7

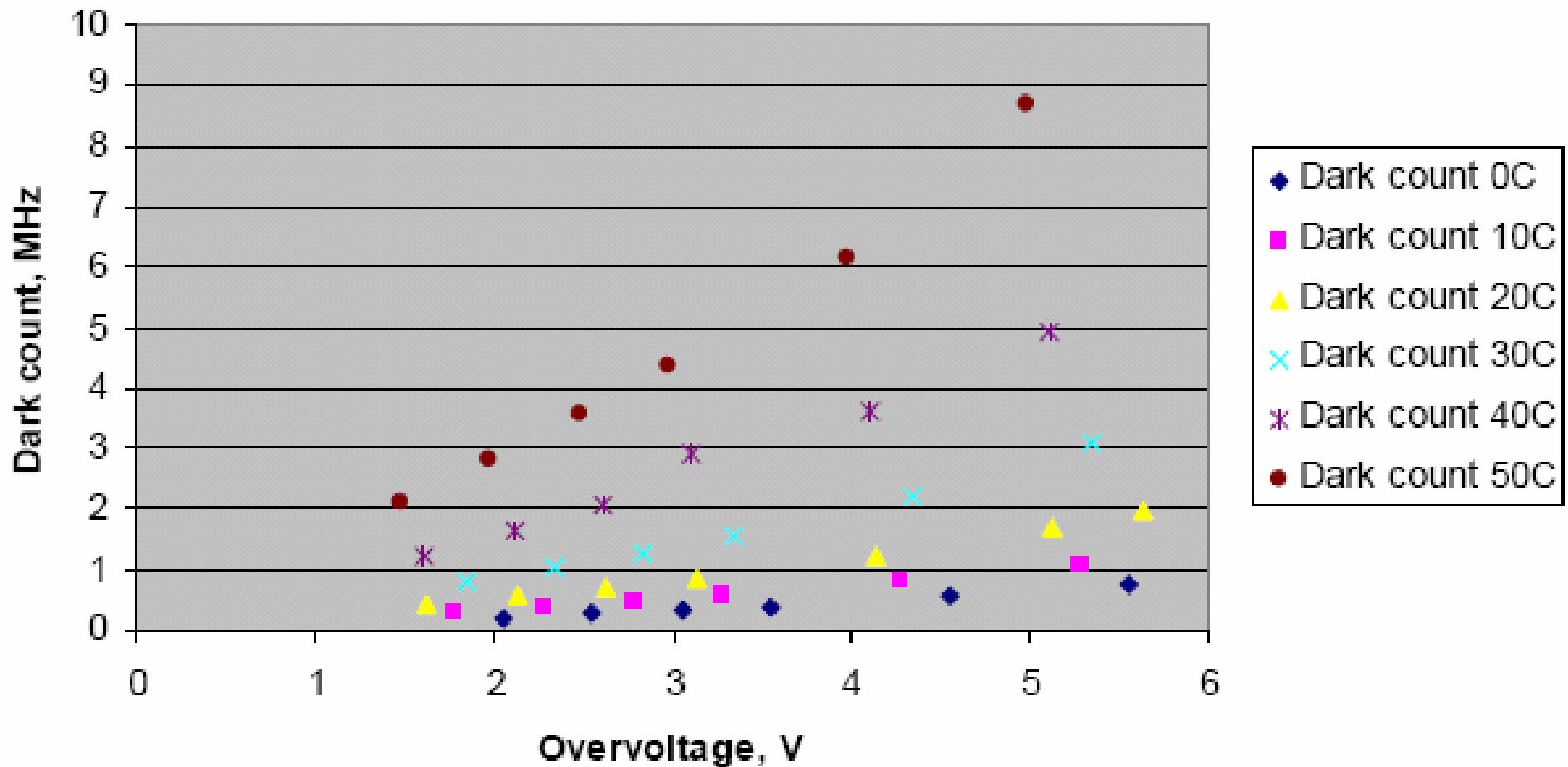
IRST\_D1



## dynamic measurements-8

## Temperature dependences - 3

IRST\_D1, Dark count

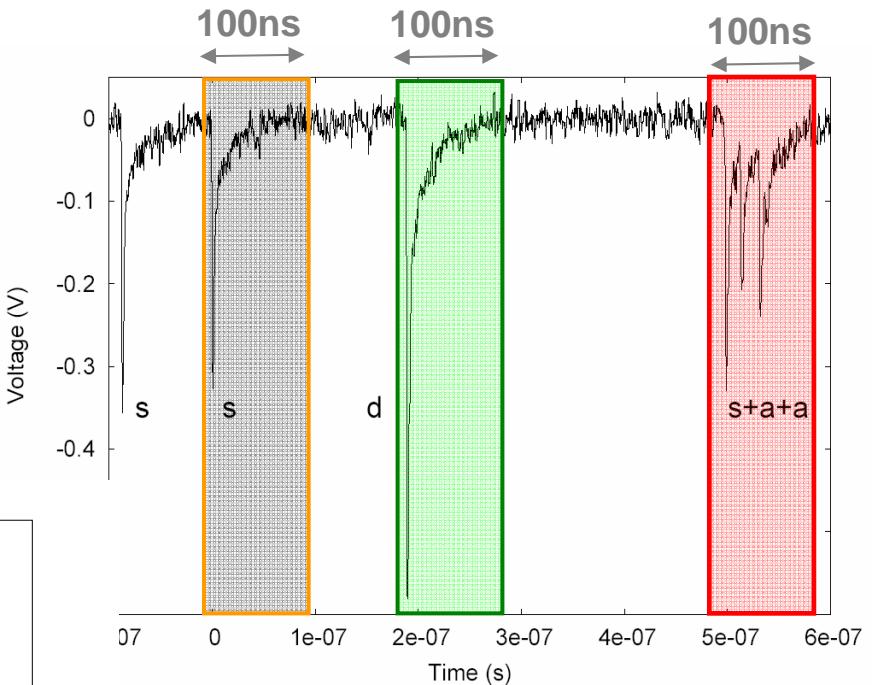
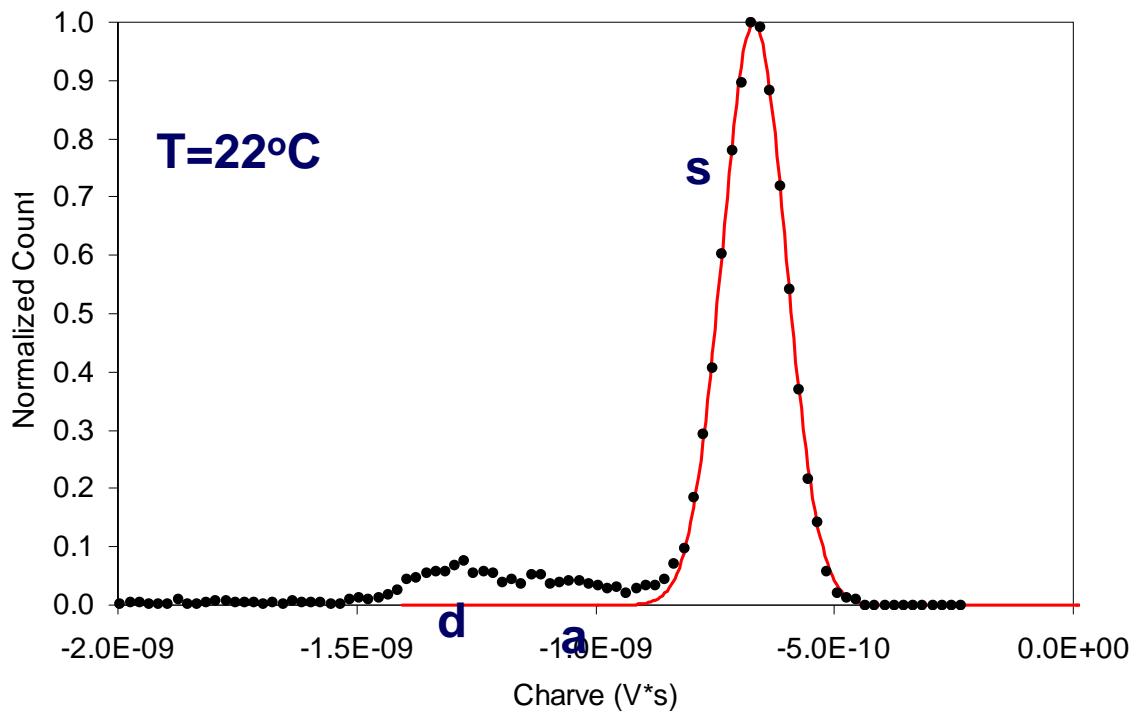


The following are static measurements performed at  
ITC-IRST and reported on at a recent (June 13<sup>th</sup> 2007)  
workshop at Perugia

# Signal properties

## Charge spectra – $T_{int}=100\text{ns}$

C. Piemonte et al. "Characterization of the first prototypes of SiPM fabricated at ITC-irst"  
IEEE TNS, February 2007

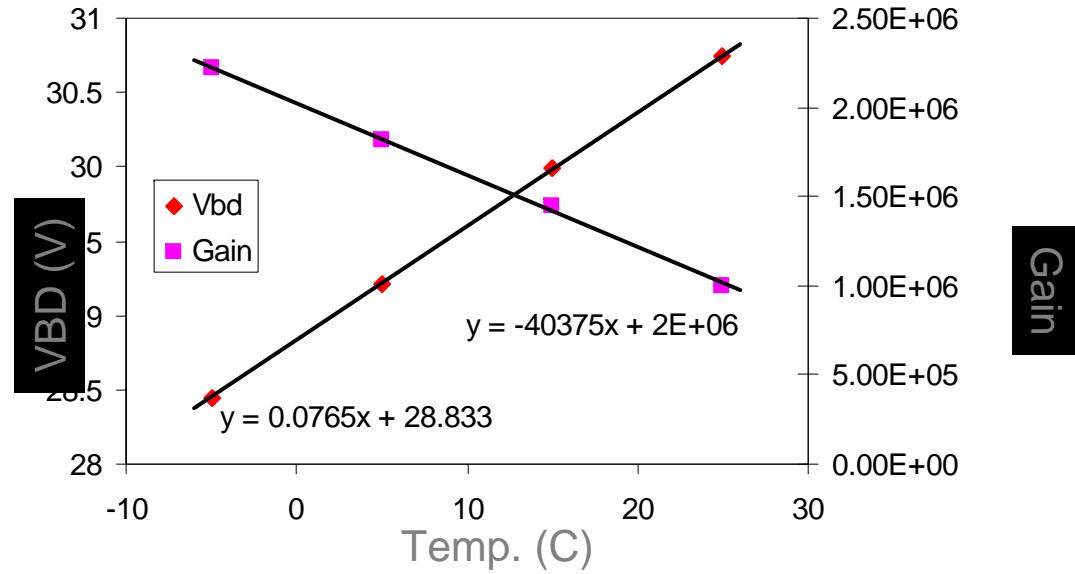
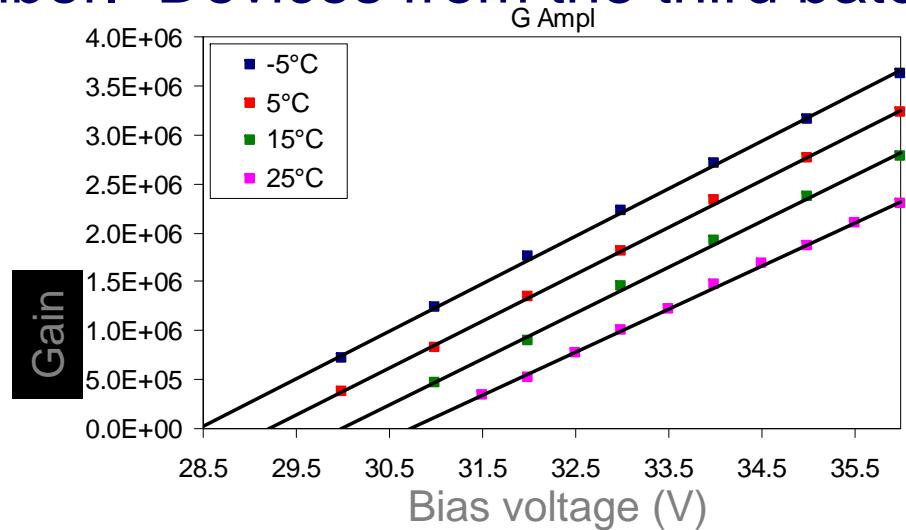
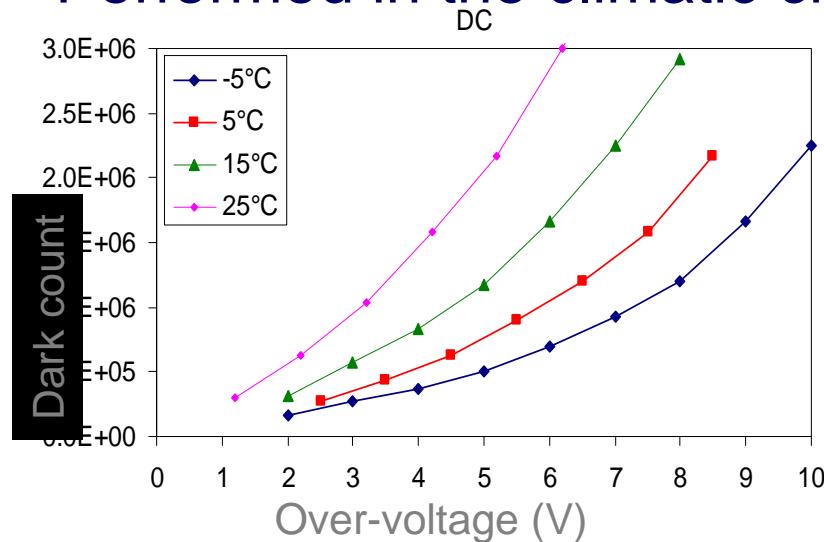


**Well defined peak of the single pulses.**  
Gaussian distribution width determined by:  
- noise of the system  
- tiny gain non-uniformities

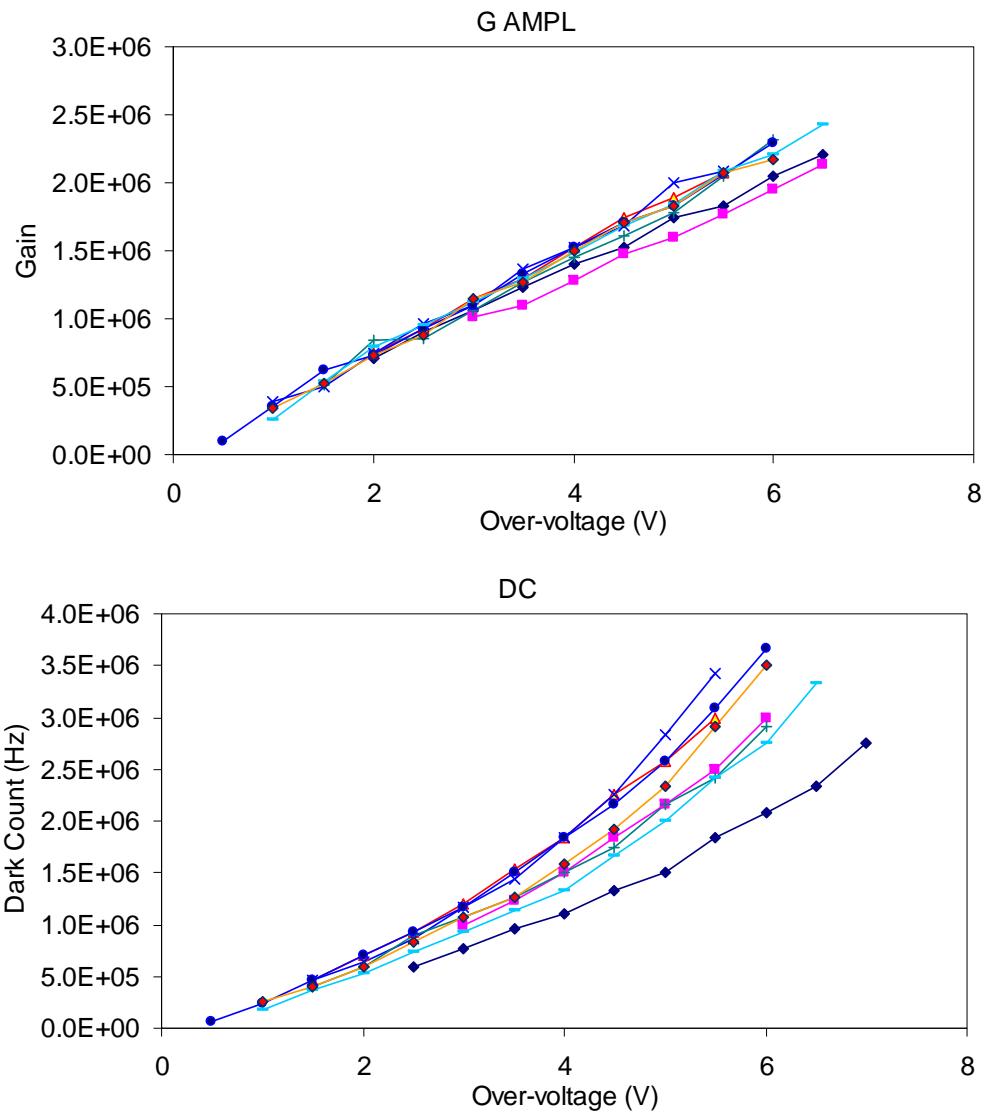
**Tails due to:**  
optical cross-talk + afterpulse

# Gain & Dark count

Performed in the climatic chamber. Devices from the third batch

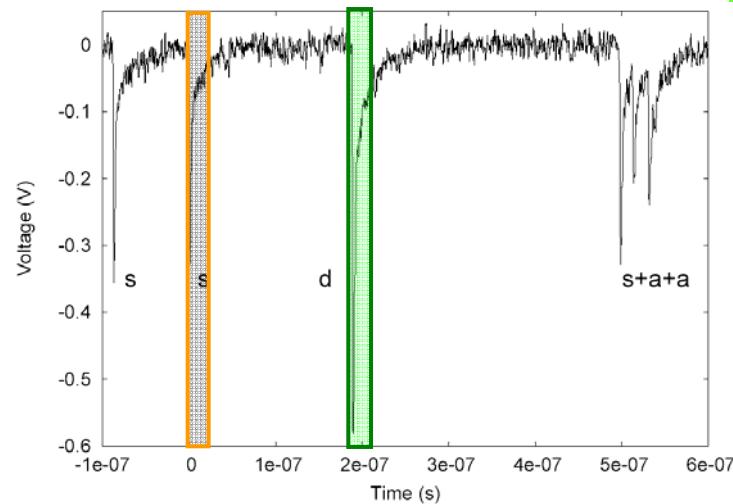


# Gain & Dark count (uniformity)



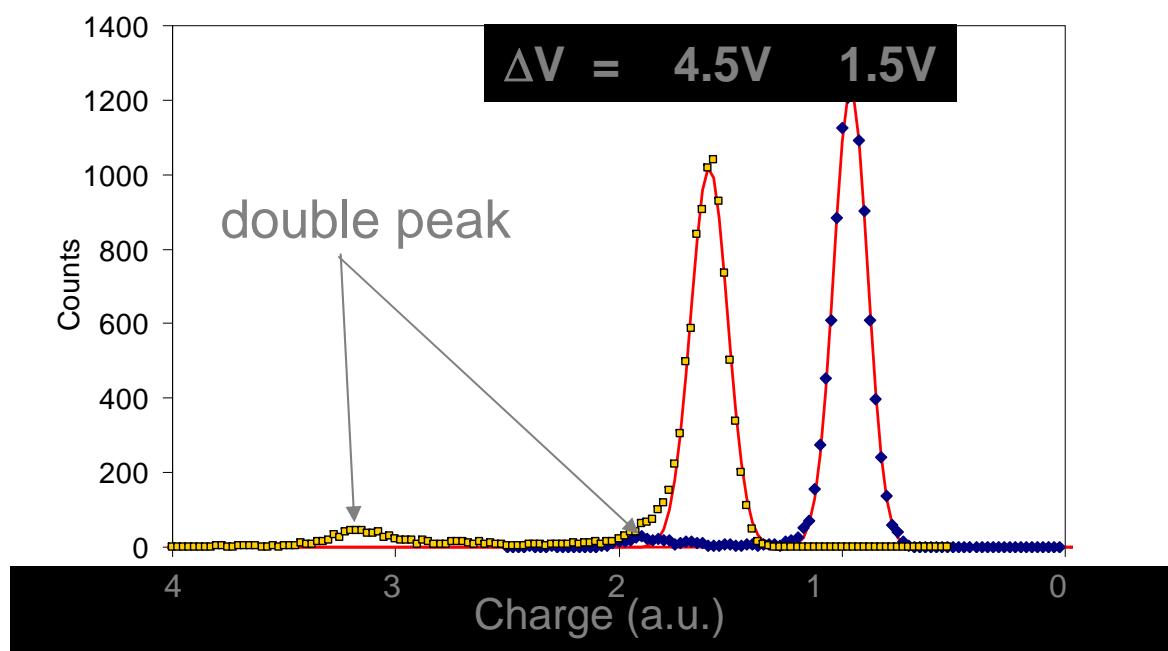
**Gain and Dark count measured on devices from the same wafer**

# Optical cross-talk



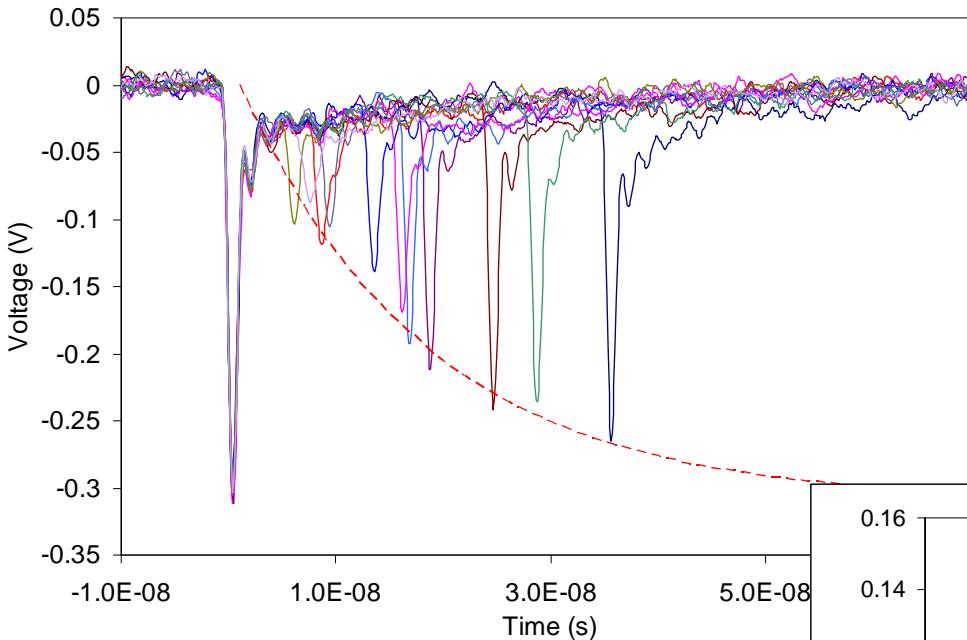
Short integration time  
⇒ only single/double/....pulses  
are counted

Number of events with  
optical cross-talk increases  
with voltage



Cross-talk below 5%  
at 4V over-voltage.

# After-pulsing



Events with after-pulse measured on a single micropixel.

The amplitude of the after-pulse increases as the cell recovers to its operational condition

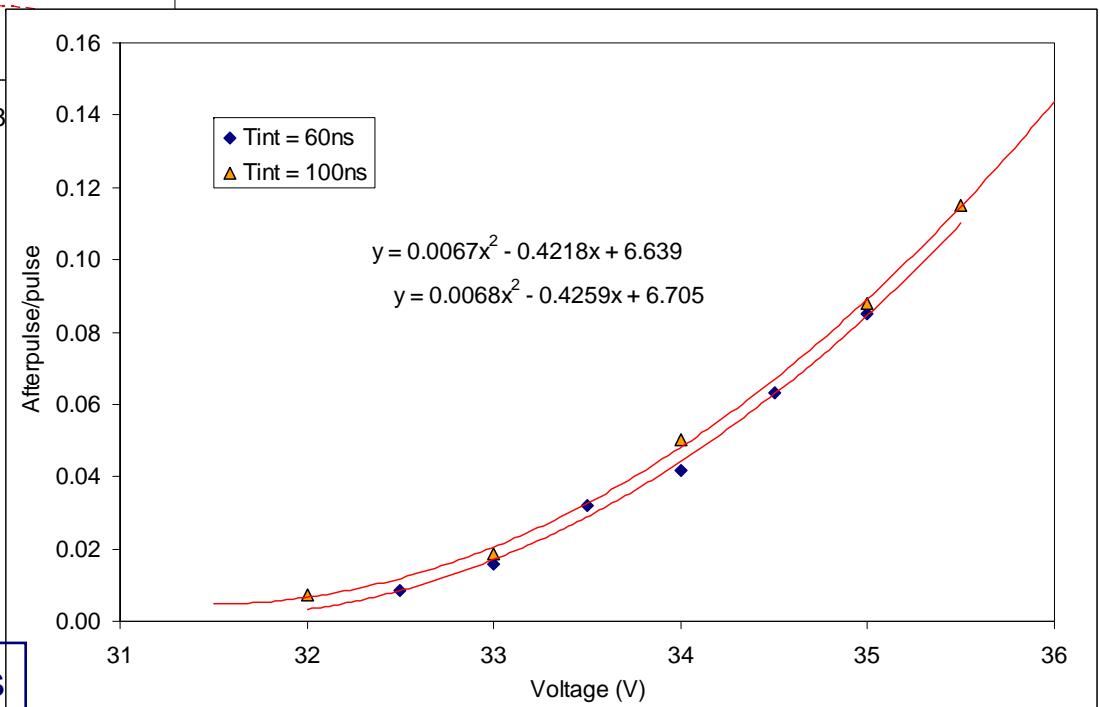
## After-pulse probability vs bias

It increases following a parabolic law:

$$P_a = P_c \cdot P_{01}$$

linear with Vbias

linear with Vbias



# Photo-detection efficiency

$$PDE = \frac{N_{\text{detected photons}}}{N_{\text{incident photons}}}$$

Reference by calibrated detector  
(photodiode)

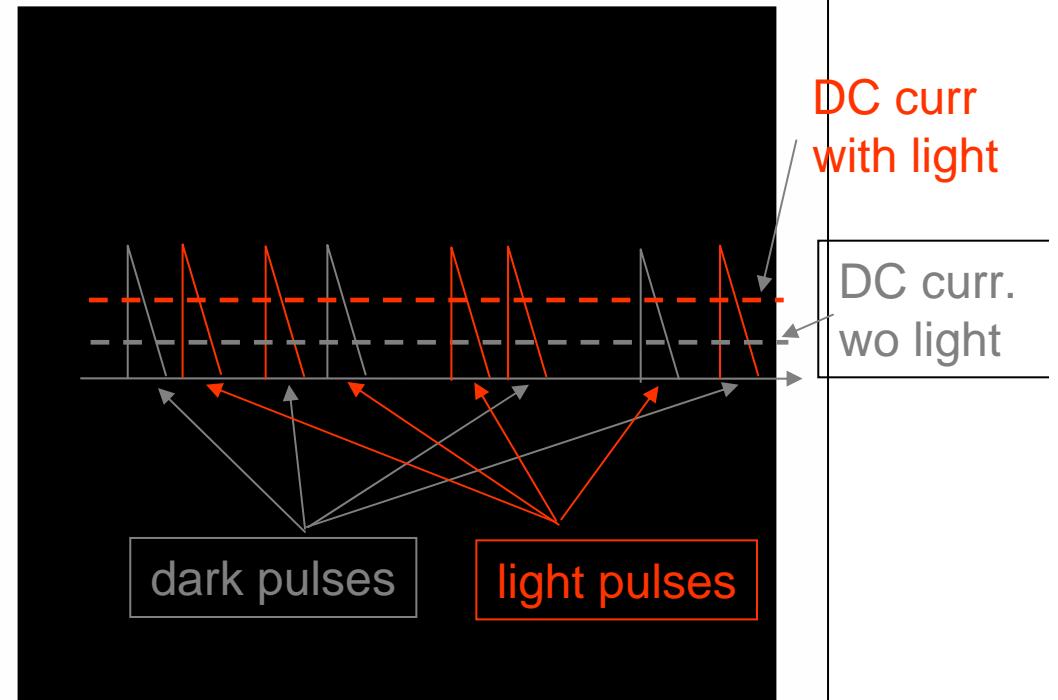
$$N_{\text{incident photons}} [\text{s}^{-1} \text{mm}^{-2}] = \Phi_{[\text{W/mm}^2]} \frac{\lambda}{hc}$$

$$\Phi_{[\text{W/mm}^2]} = \alpha_{[\text{W/A}]} \frac{I_{[\text{A}]}}{S_{[\text{mm}^2]}}$$

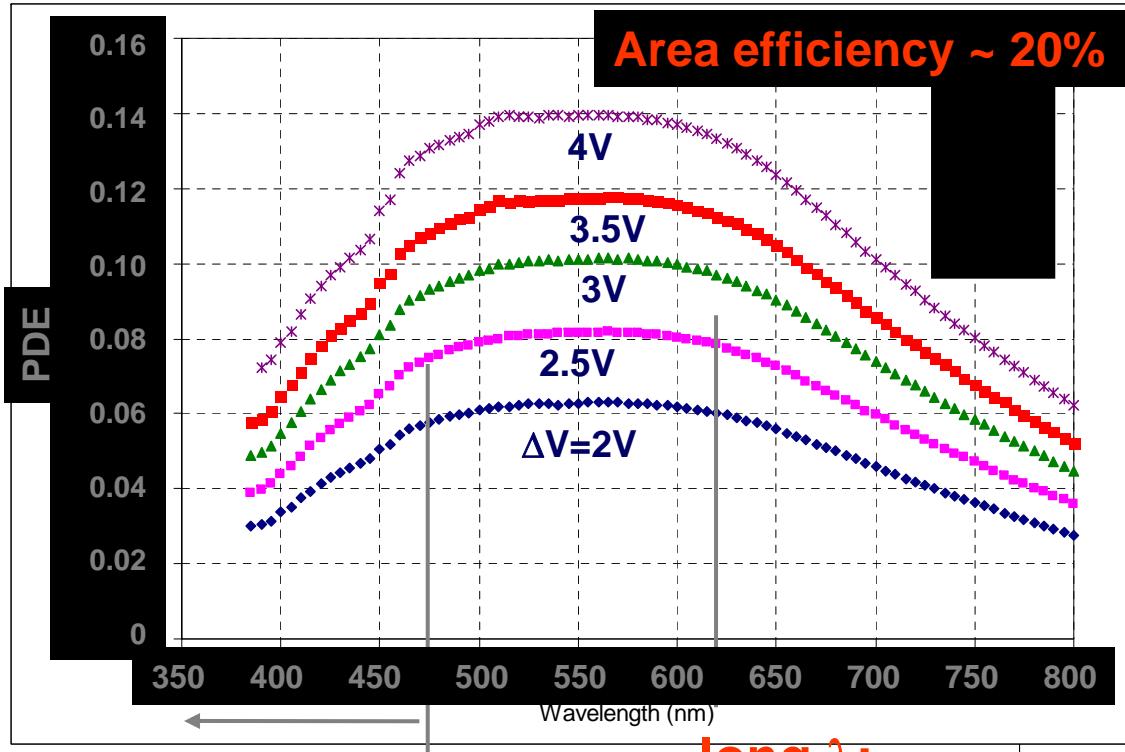
Two methods: DC current and Pulses count

$$(1) N_{\text{det. photons}} [\text{s}^{-1}] = \frac{I_{\text{light}} - I_{\text{dark}}}{q \cdot G}$$

$$(2) N_{\text{det. photons}} [\text{s}^{-1}] = \text{Rate}_{\text{light}} - \text{Rate}_{\text{dark}}$$



# Photodetection efficiency

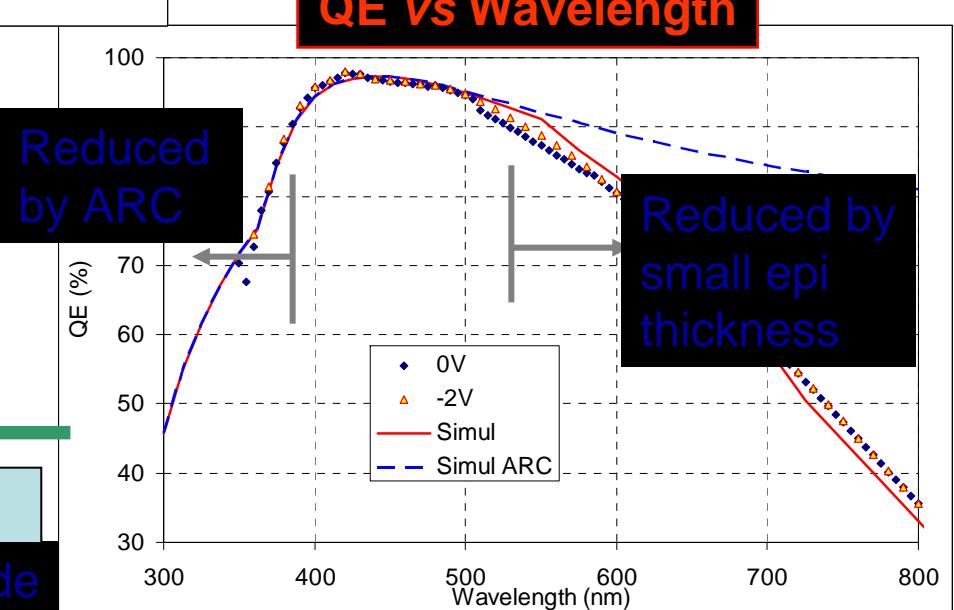


**short  $\lambda$ :**  
low PDE  
because  
avalanche  
triggered by  
holes

**long  $\lambda$ :**  
low PDE  
because  
low QE

$$PDE = QE \cdot P_t \cdot A_e$$

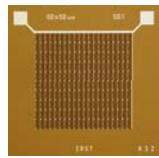
QE = quantum eff.  
P<sub>t</sub> = avalanche prob.  
A<sub>e</sub> = area eff.



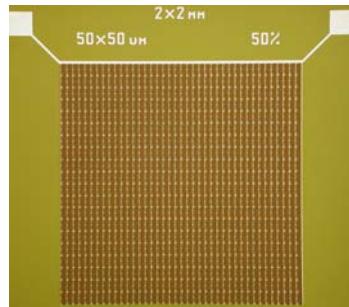
C. Piemonte: June 13<sup>th</sup>, 2007, Perugia

Measured on a diode

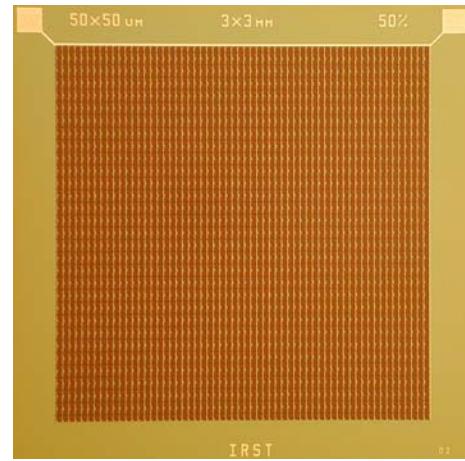
# last batch



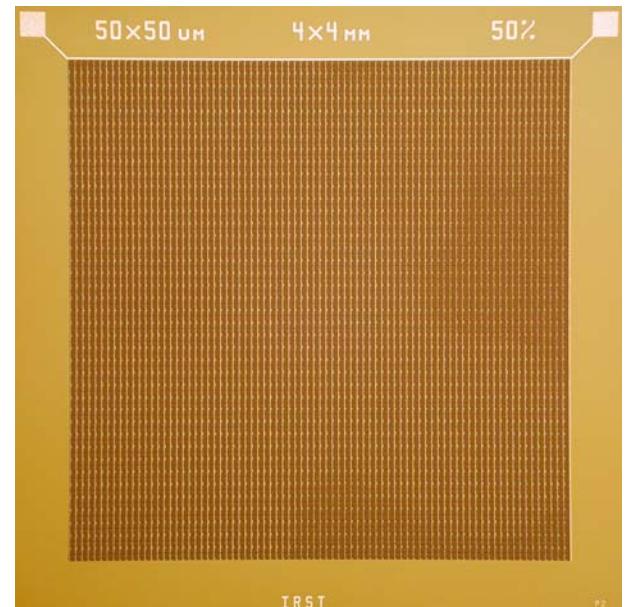
1x1mm



2x2mm



3x3mm (3600 cells)



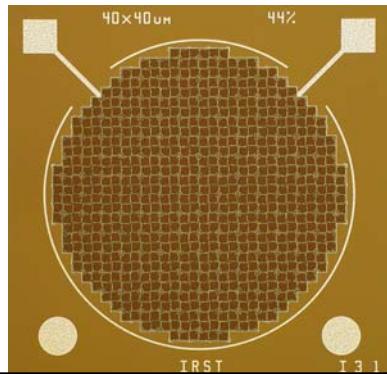
4x4mm (6400 cells)

**increased fill factor:**

**40x40mm => 44%**

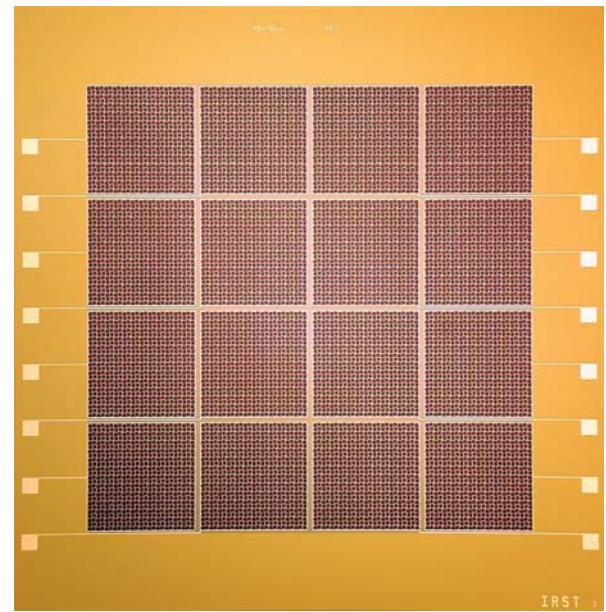
**50x50mm => 50%**

**100x100mm => 76%;**



Circular  
(1.2 mm –  
diameter)

Array



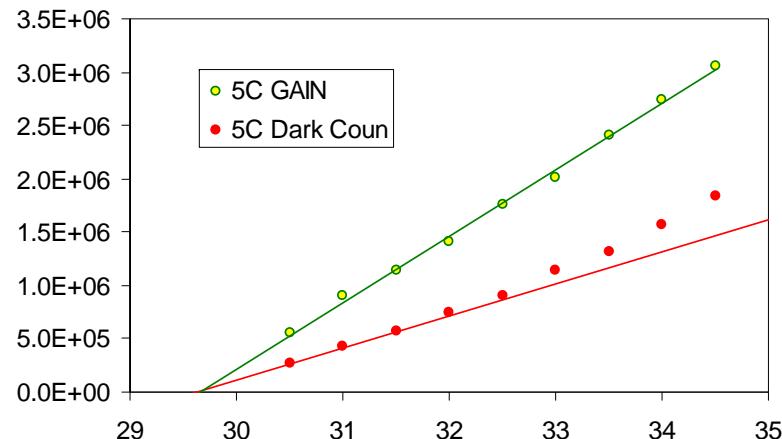
C. Piemonte: June 13<sup>th</sup>, 2007, Perugia

# First signal and noise characteristics of the last devices

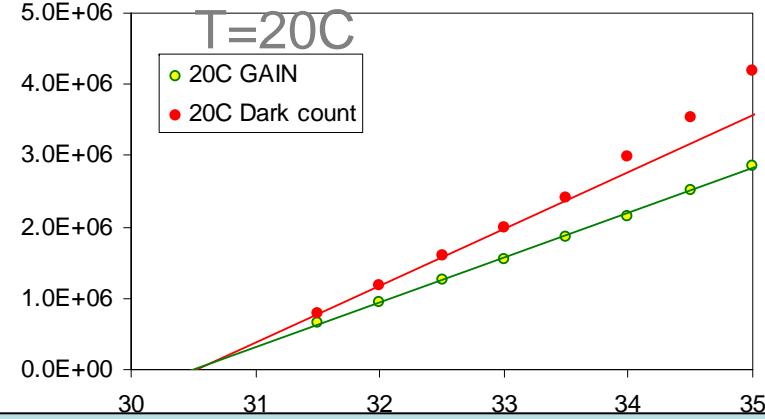
## Noise and charge resolution

1x1mm<sup>2</sup> SiPM with 40x40μm<sup>2</sup> cells

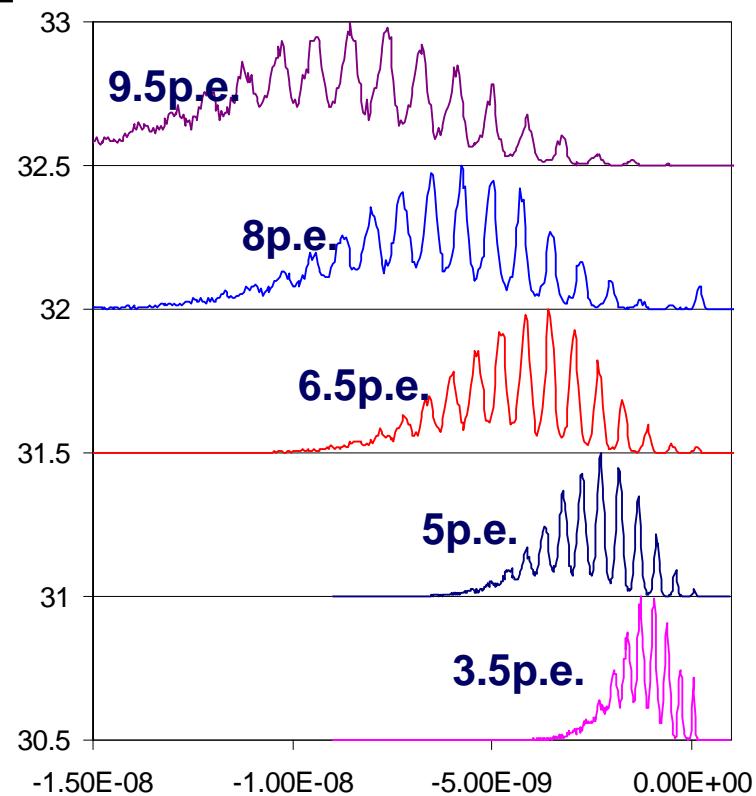
T=5C



T=20C



Charge spectra at different Voltages with the same light Intensity (pulsed)



resolution limited by electronic noise

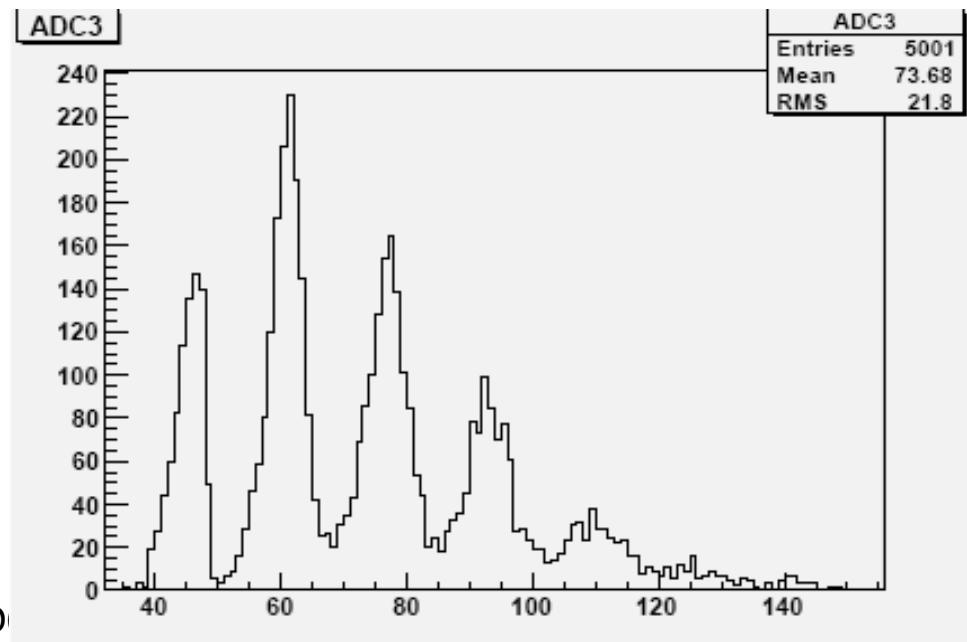
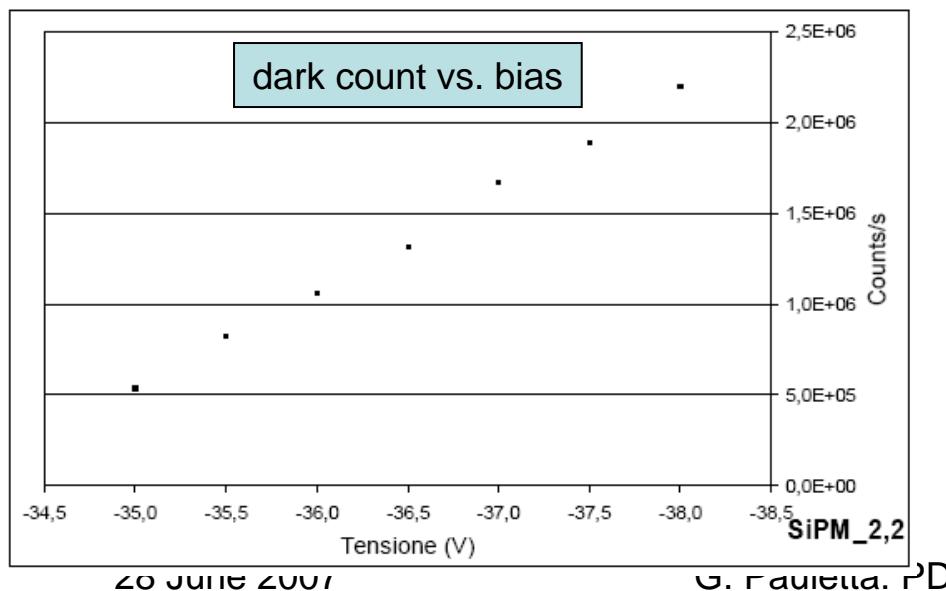
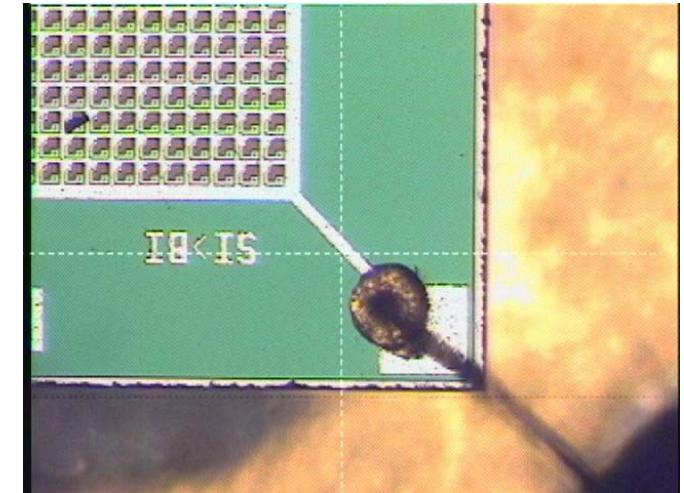
# applications

# Characterization of SiPMs (1 mm<sup>2</sup> from second batch) used for preliminary at Fnal test beam

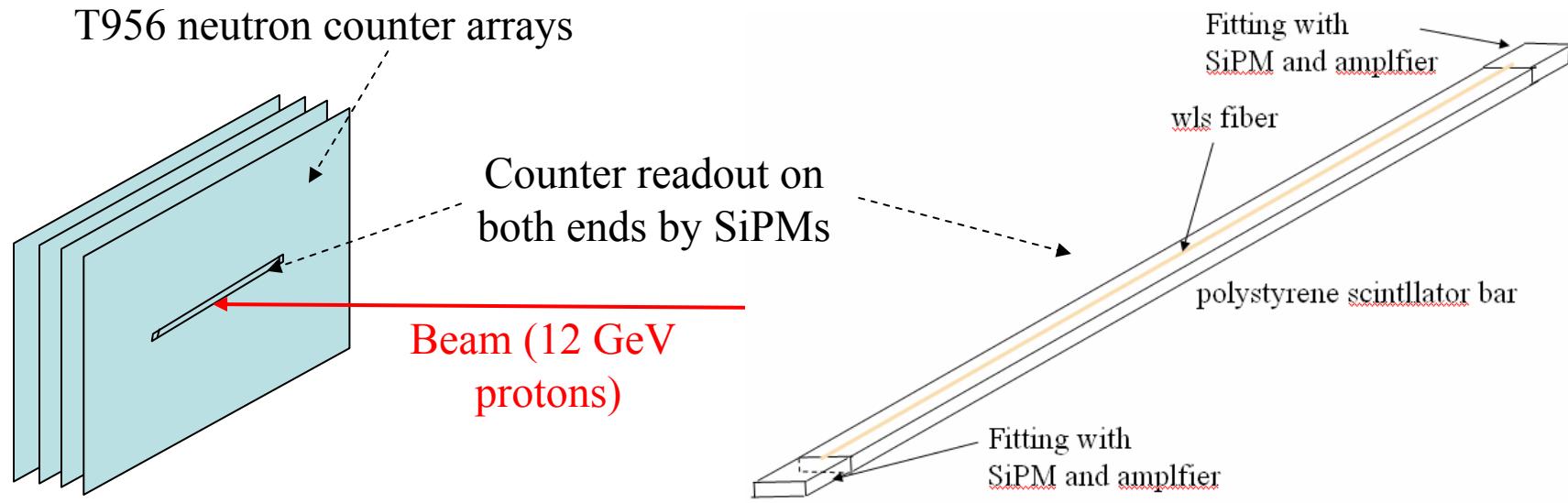
Visual inspections (SiDet) and dynamic tests at lab 6 prior to use of SiPMs in Test Beam yielded results compatible with IRST measurements:

$$V_B = 34.1 \text{ V}$$

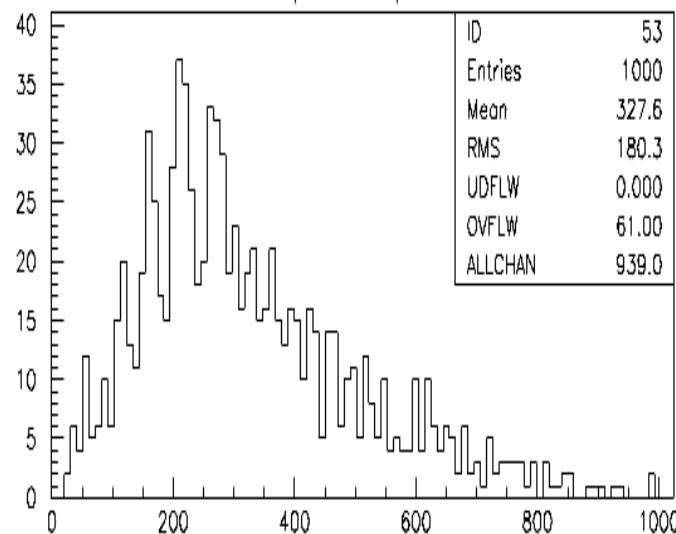
Gains between  $\sim 1$  and  $2 \times 10^6$



# Preliminary study of Scint. Strip viewed by IRST SiPM at the FNAL test beam



Bias = -36V ( $\Delta V=2V$ )



Data with 120 Gev proton - beam

$$N_{p.e.} \approx 6.5 p.e.$$

$$\epsilon = 99\%$$

$$N_{d.c.} \approx 1.5 MHz$$

$$G \approx 1.6 \times 10^6$$

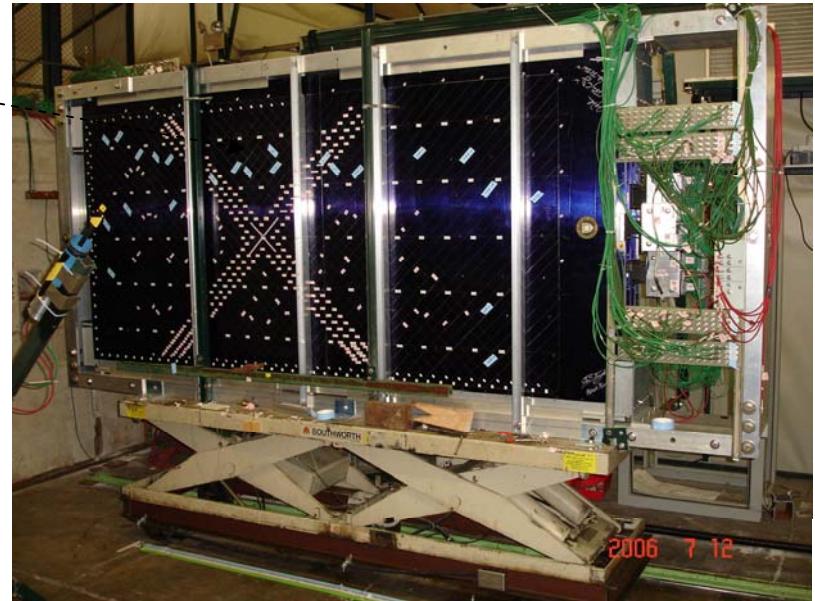
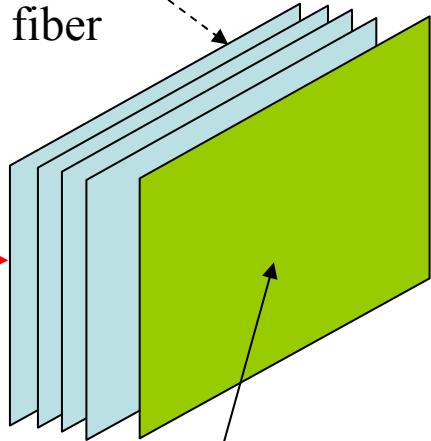
: PD07, Kobe, Japan

## Future work at fnal

T956 neutron counter arrays:

64 scint strips each  
(read out by wls fiber  
and MAPMTs)

Beam ( $p, \pi, e$ )



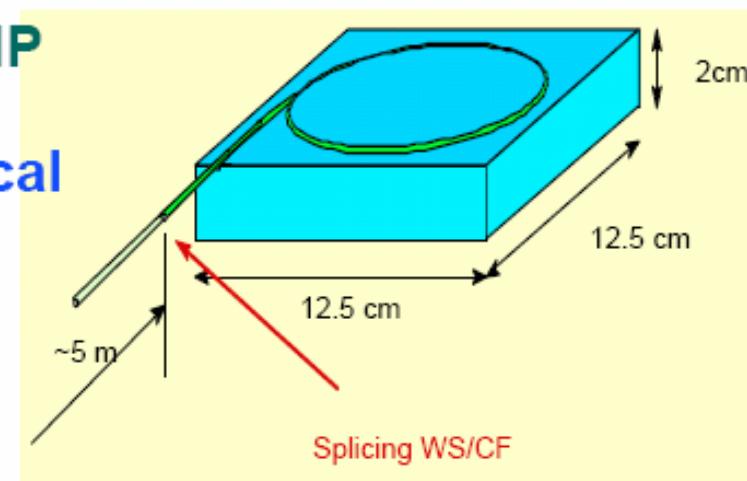
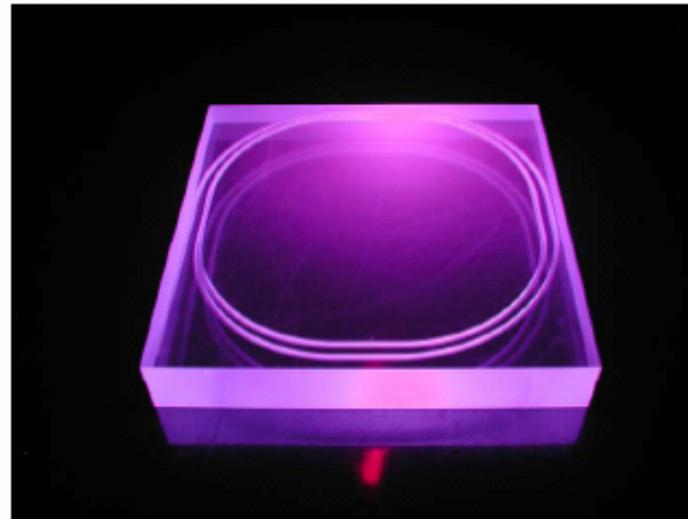
Whole assembly mounted on  
movable (x,y) support

Scintillator strips : 4cm x 1cm x (1 – 2 m), read out by wls fiber. Groove for fiber  
extruded with scintillator



## Tiles used for Ts/Ud tests

- Dubna scintillator + keyhole/double-spiral groove + 3M super-reflector
- Kuraray fiber achieved 37 pe/MIP without optical glue, 44 pe/MIP with glue.
- Lose x3-4 along optical path to PMT (attenuation+splice+connector)



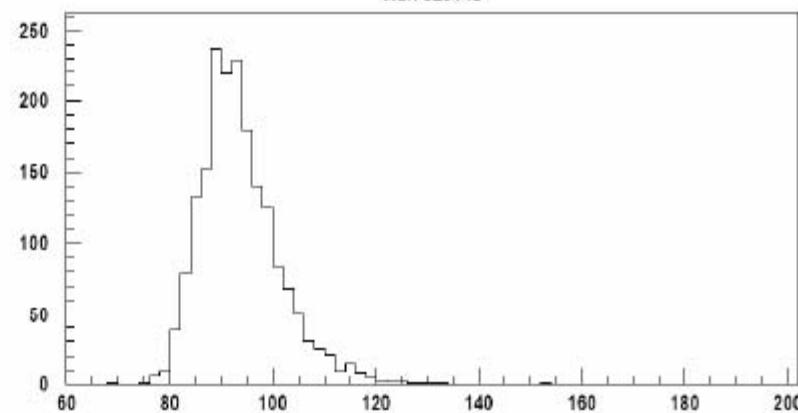
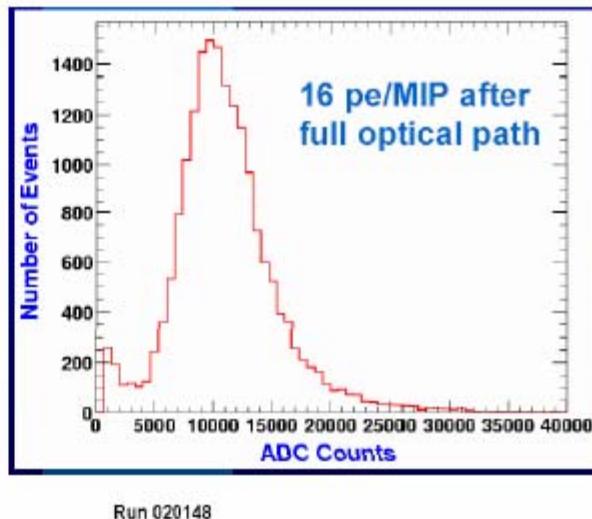
# Performance (MIP)

with

PMT

and

SiPM



## Fiber application study: Fiber Arrays

